

Development of a THGEM-based photon detector for RICH applications

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on behalf of an Alessandria-CERN-Freiburg-Liberec-Prague-Torino-Trieste Collaboration

Introduction

Characterization of single THGEMs

Study of photoelectron extraction

Tests with multilayer THGEMs

Present status and perspectives



Motivations for this R&D program

At present the only economic way to cover with photon detectors very large surfaces is to use gaseous photon detectors.

MWPC's with CsI are successfully used, but:

- the effective gain is moderate (~10,000)
- the efficiency is challenged by aging (~1 mC/cm²)
- the signal is slow, coming from the ions drift (~100 ns)
- the electrical stability in an experimental environment is limited and the recovery time after detector trip is long (~1 d)

Performances in terms of rate capability and noise rejection cannot be increased without a change of technology, possibly in the direction of:

- using a closed geometry to avoid photon feedback
- minimize ion backflow to the CsI layer
- detecting signals from electron drift (few ns)
- using simple and robust components

We decided to try using THGEM's and reflective CsI photocathodes

No need of high space resolution ($> 1 \text{ mm}$)

Large area coverage (5.5 m² for COMPASS RICH)

- industrial production (standard pcb)
- good stiffness
- very robust against discharge damages

For reflective photocathodes,

- no need to keep the window at a fixed potential (2nm Cr $\rightarrow -20\%$)
- possibility of windowless geometry
- higher effective QE (larger pe extraction probability)

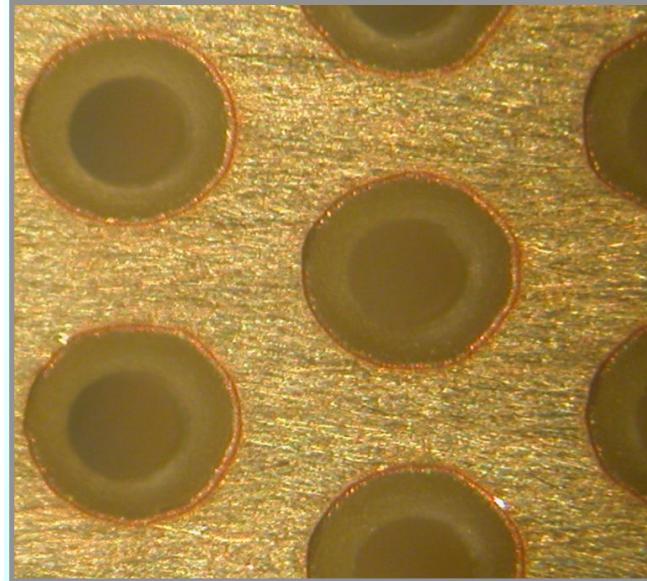
→ small photoconversion dead zones possible (~20%; GEM ~ 40%)

Large gain: $> 10^6$

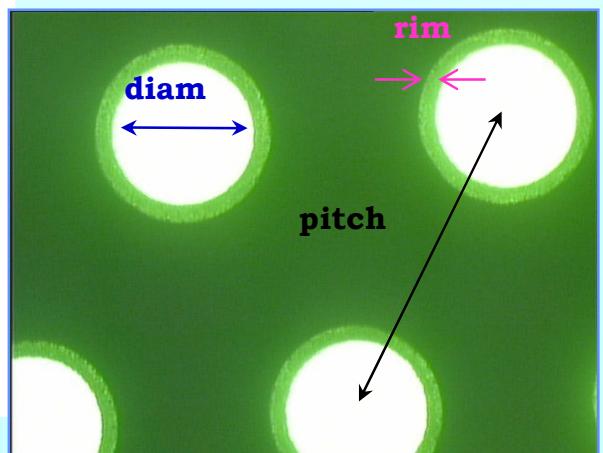
About two years ago we started a program to develop a suitable detector from existing experience and literature on THGEM's.

First step: testing the performances of THGEM's as electron multipliers:

- range of attainable gains
- reproducibility and stability in time of the THGEM response
- role of the geometrical parameters:
 - thickness, hole diameter, pitch, rim size
- dependence on THGEM material and production procedures
- performances in different operating conditions



Picture at the microscope



SETUP of the initial tests

Single THGEM layer in the chamber, active surface: 30 x 30 mm²;

Gas mixture Argon/CO₂ (70/30)

Sources: X-Ray (Cu - collimated source) and ⁵⁵Fe (uniform irradiation);

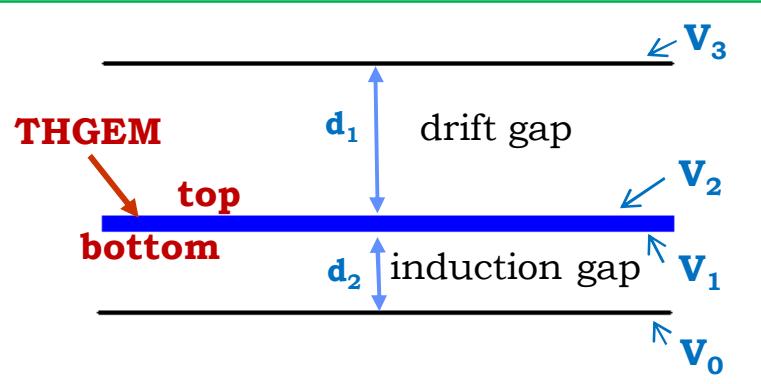
Two approaches: gain from signal amplitude spectra

and from current measurements (pico-ammeters with resolution ~1pA)

tests performed at CERN MPGD Lab. and in Trieste:
more than 30 different THGEMs tested so far

To detect ionizing particle :

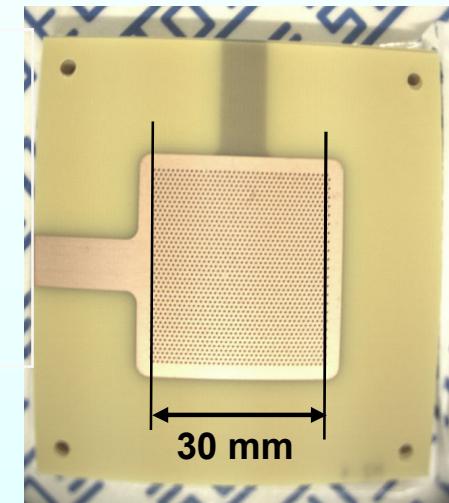
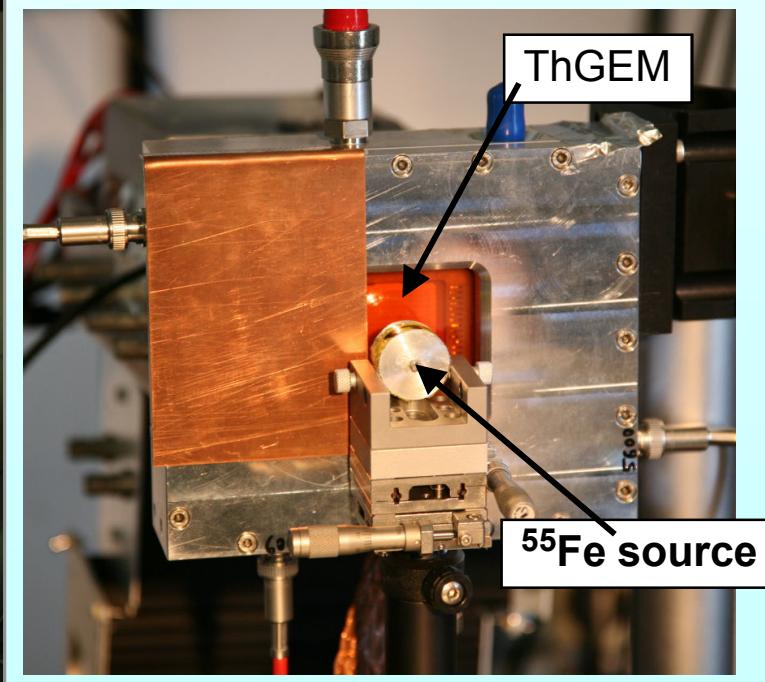
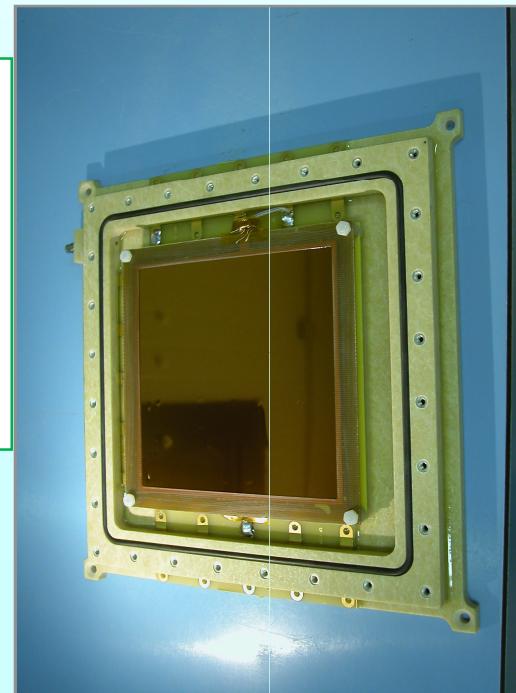
$$V_3 < V_2 < V_1 < V_0$$



$$E_{\text{drift}} = (V_3 - V_2) / d_1$$

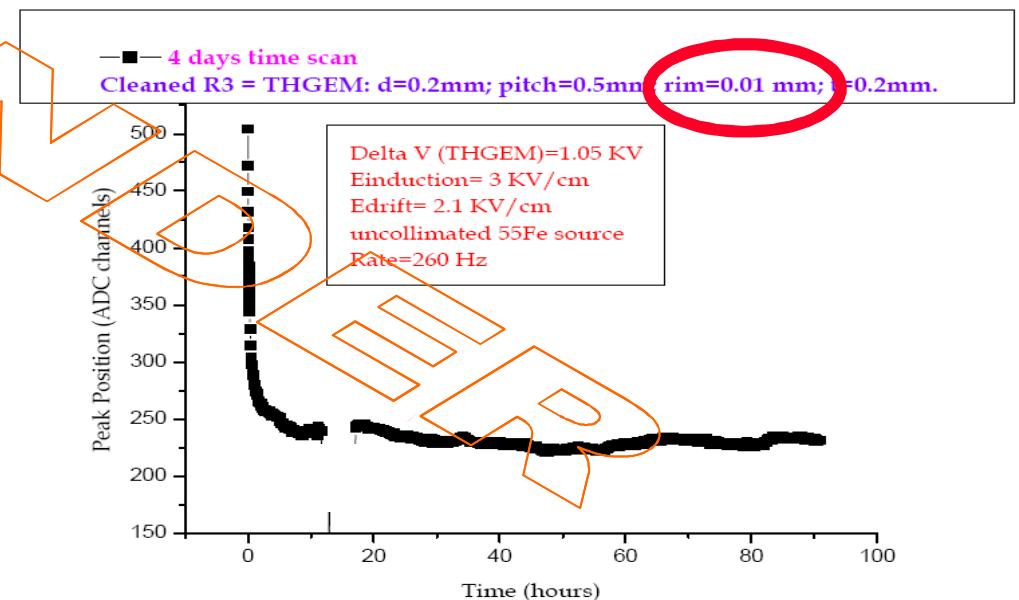
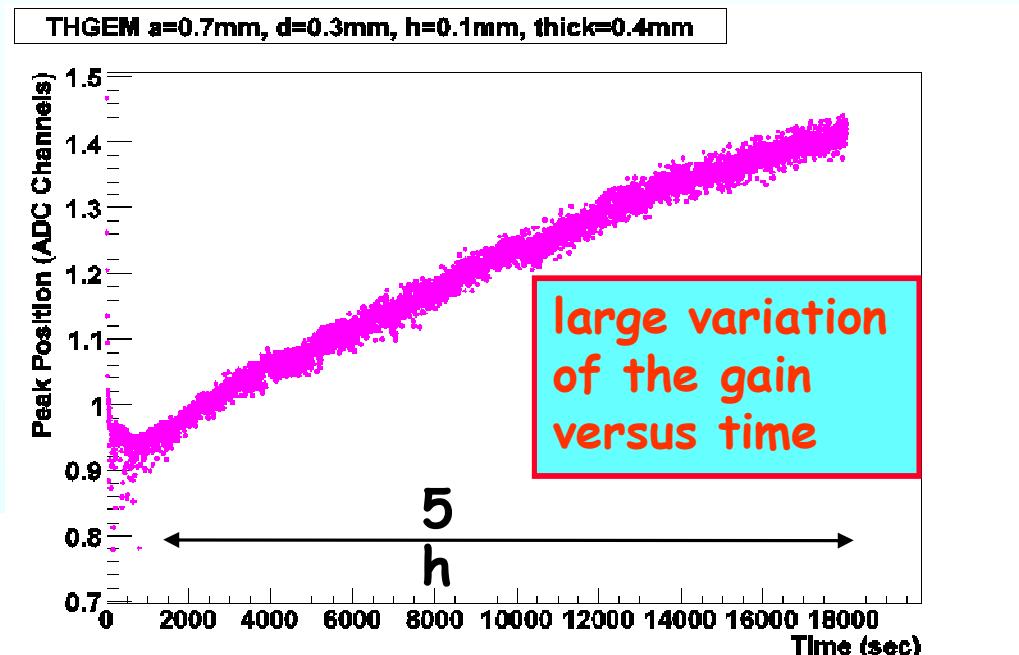
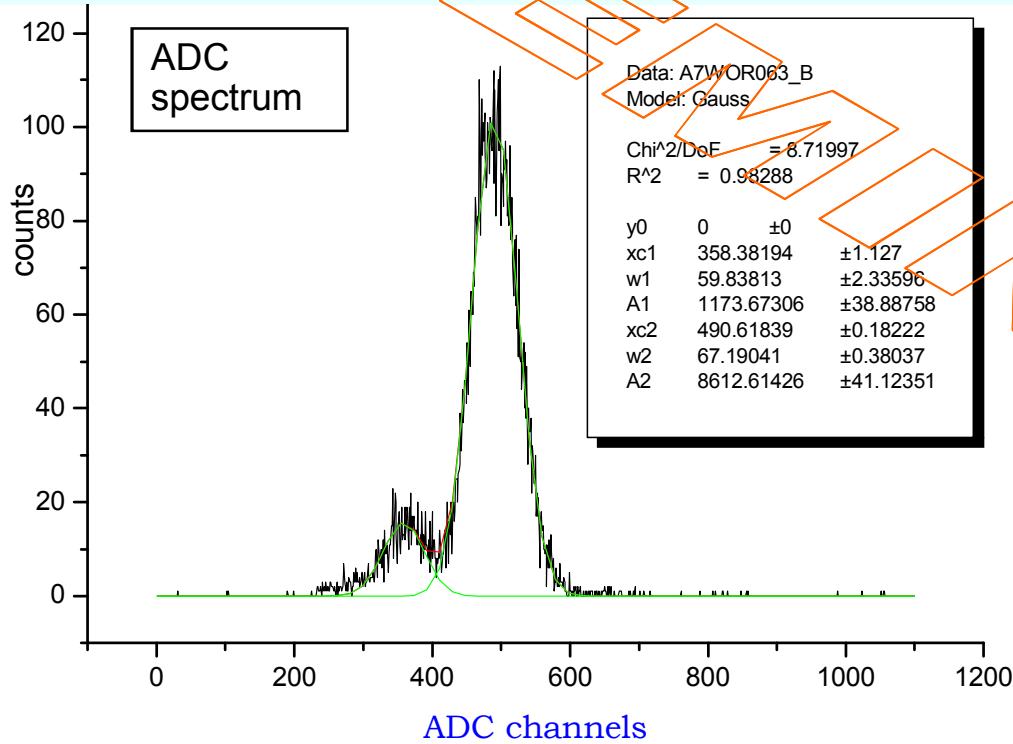
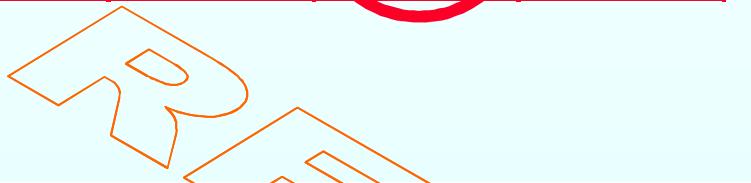
$$E_{\text{induction}} = (V_1 - V_0) / d_2$$

$$\Delta V = V_2 - V_1$$



GAIN STABILITY (1)

THGEM	Diameter (mm)	Pitch (mm)	Rim (mm)	Thick (mm)
W ₂	0.3	0.7	0.1	0.4

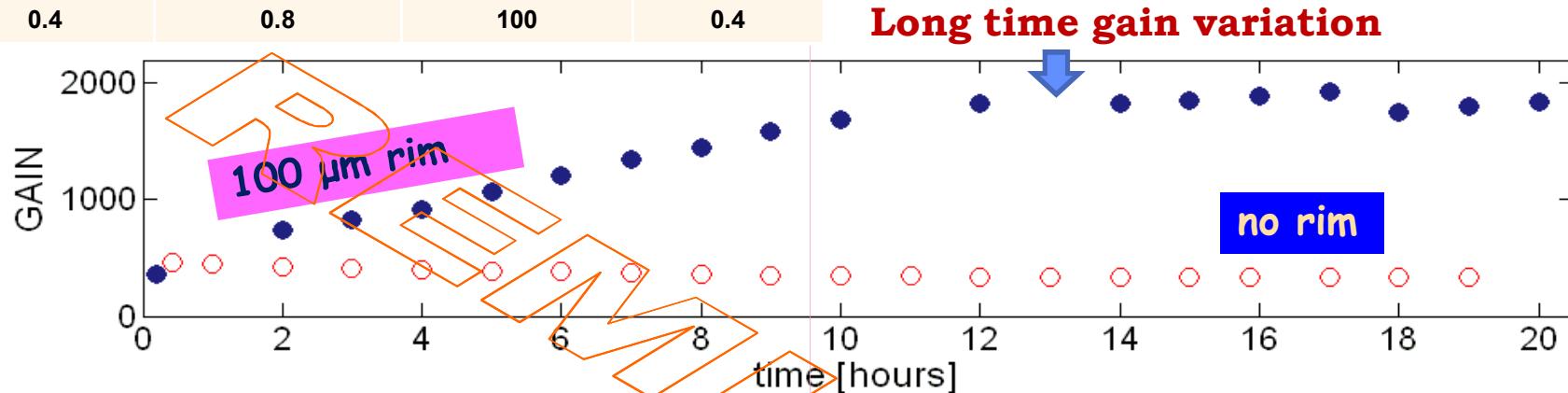


It is now clarified that the good stability (within ~20-30%) is obtained with small rim (< 20 μ m)

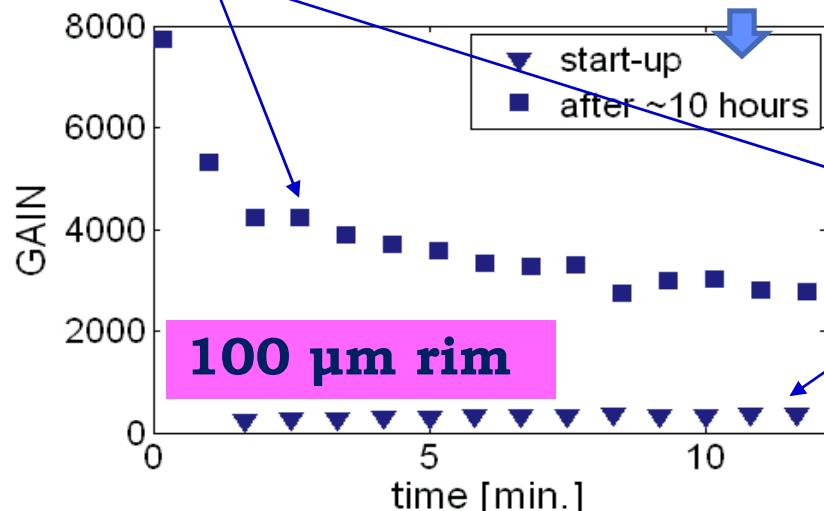
GAIN STABILITY (2)

⁵⁵Fe source;
uniform irradiation

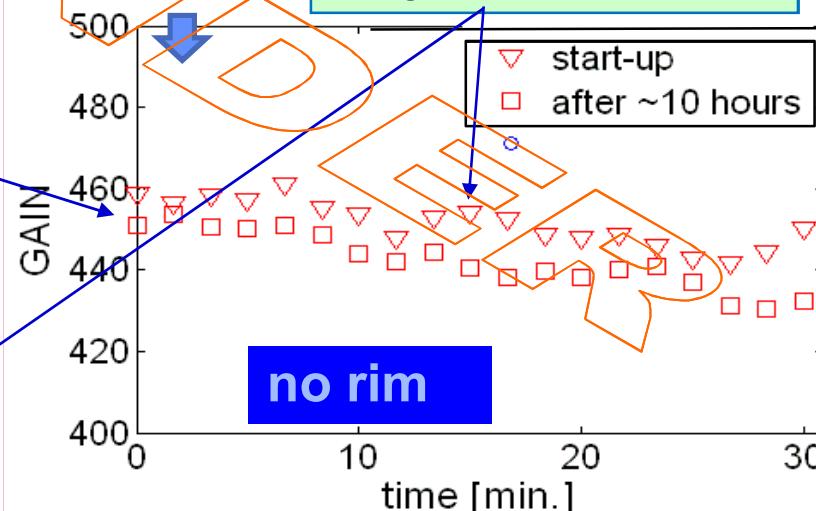
	diam (mm)	pitch (mm)	rim (μm)	thick (mm)
	0.4	0.8	0	0.4
	0.4	0.8	100	0.4



START IRRADIATING after
~10 hours at nominal voltage



irradiation at HV switch on
(after ~1 day with no
voltage)

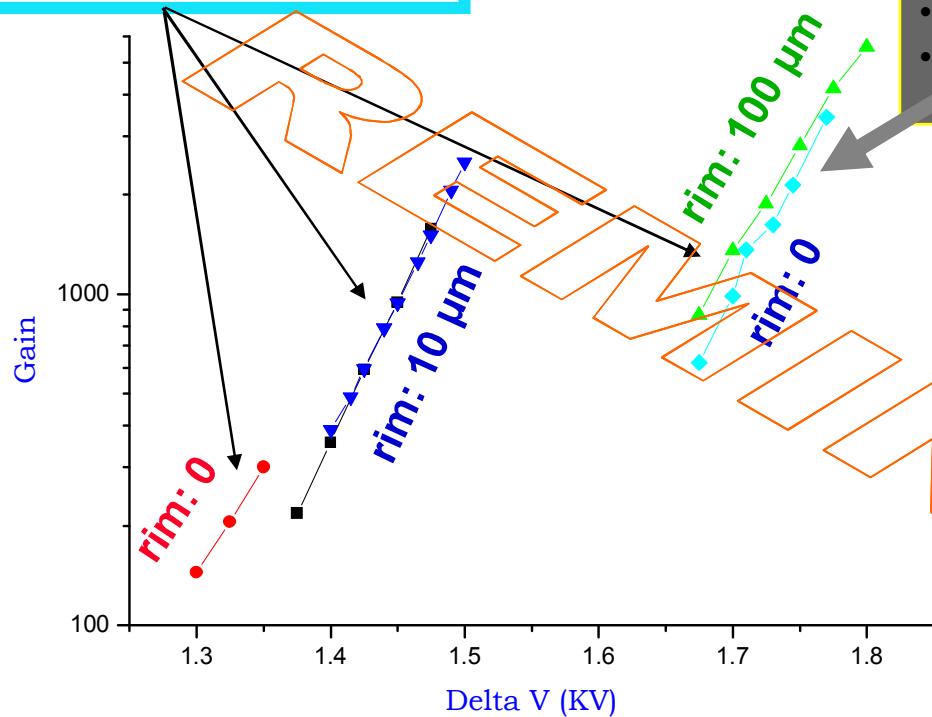


Gain ~ 4,000; rate capability ~ 10⁷/mm²

PARAMETERS:

- Diameter = 0.3 mm
- Pitch= 0.7 mm
- Thickness = 0.4 mm

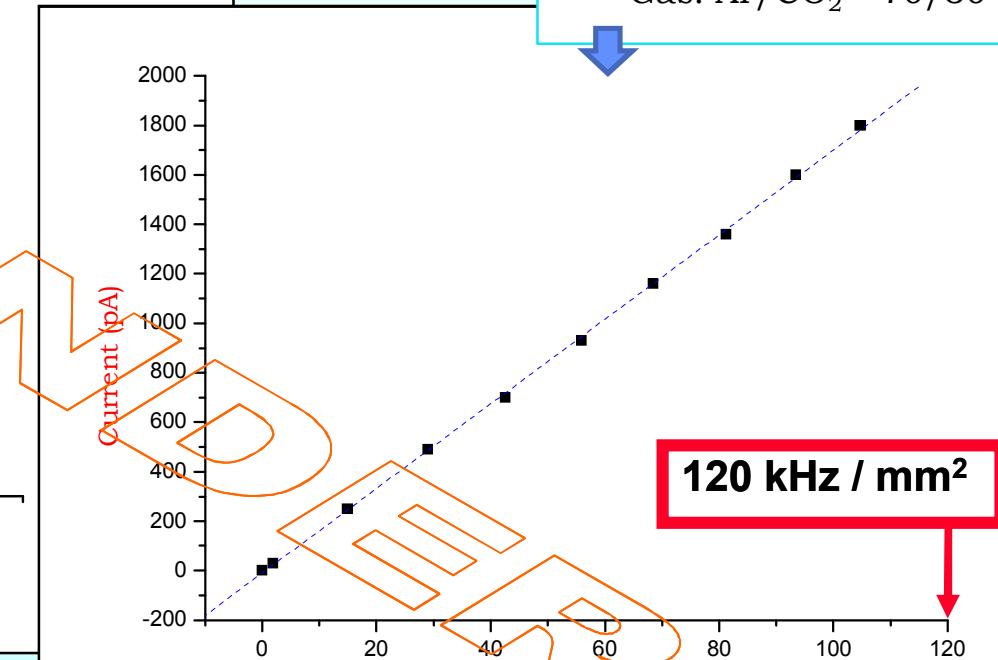
Ar/CO₂: 70/30



X-Ray Source: ~1 mm², rate ~1.7KHz.

PARAMETERS:

- Diameter = 0.3 mm
- Pitch= 0.6 mm
- Thickness = 0.6 mm
- Rim = 0 mm
- Gas: Ar/CO₂ – 70/30

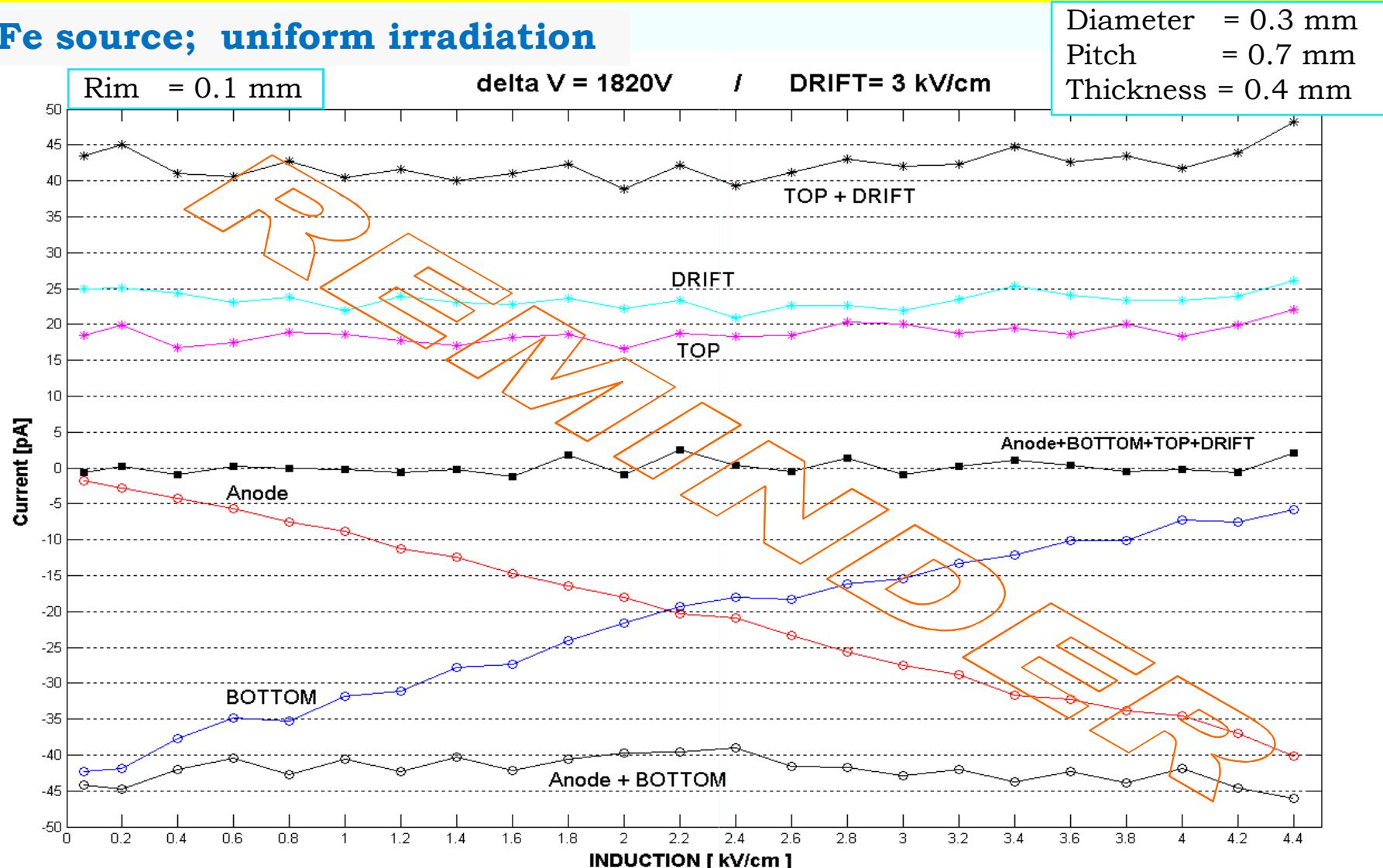


120 kHz / mm²

120 kHz/ mm², 300 e⁻ → single photoelectron rates of ~35 MHz/ mm²

The value of E_{ind} defines the charge shearing between THGEM bottom and anode

^{55}Fe source; uniform irradiation



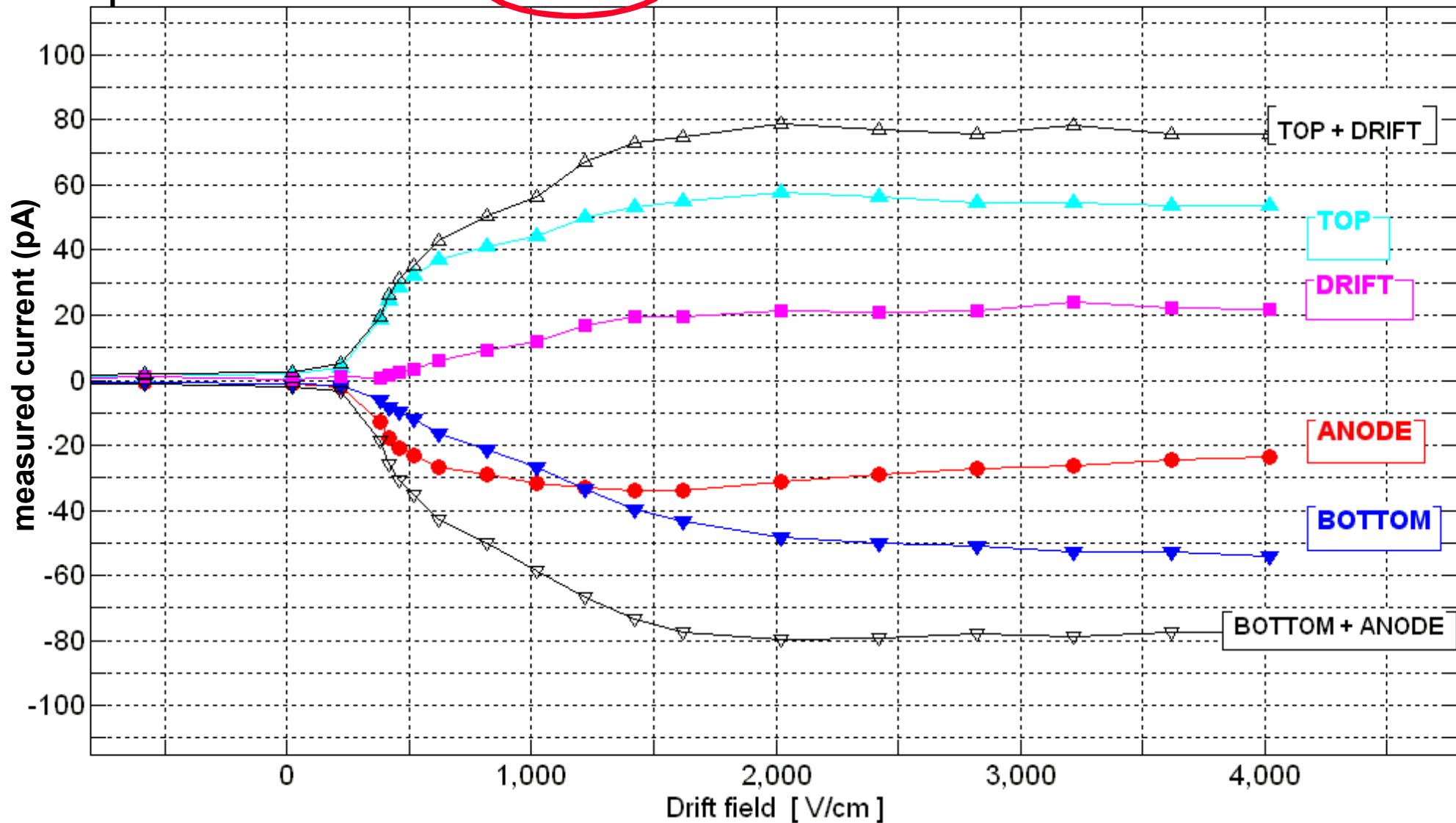
primary e^- collection efficiency vs E_{drift}

Drift scan

sample: M2.4

thickness: 0.6mm, diameter: 0.4mm, pitch: 0.8mm, NO RIM

delta-V = 1690 V
Induction field = 3000 V/cm



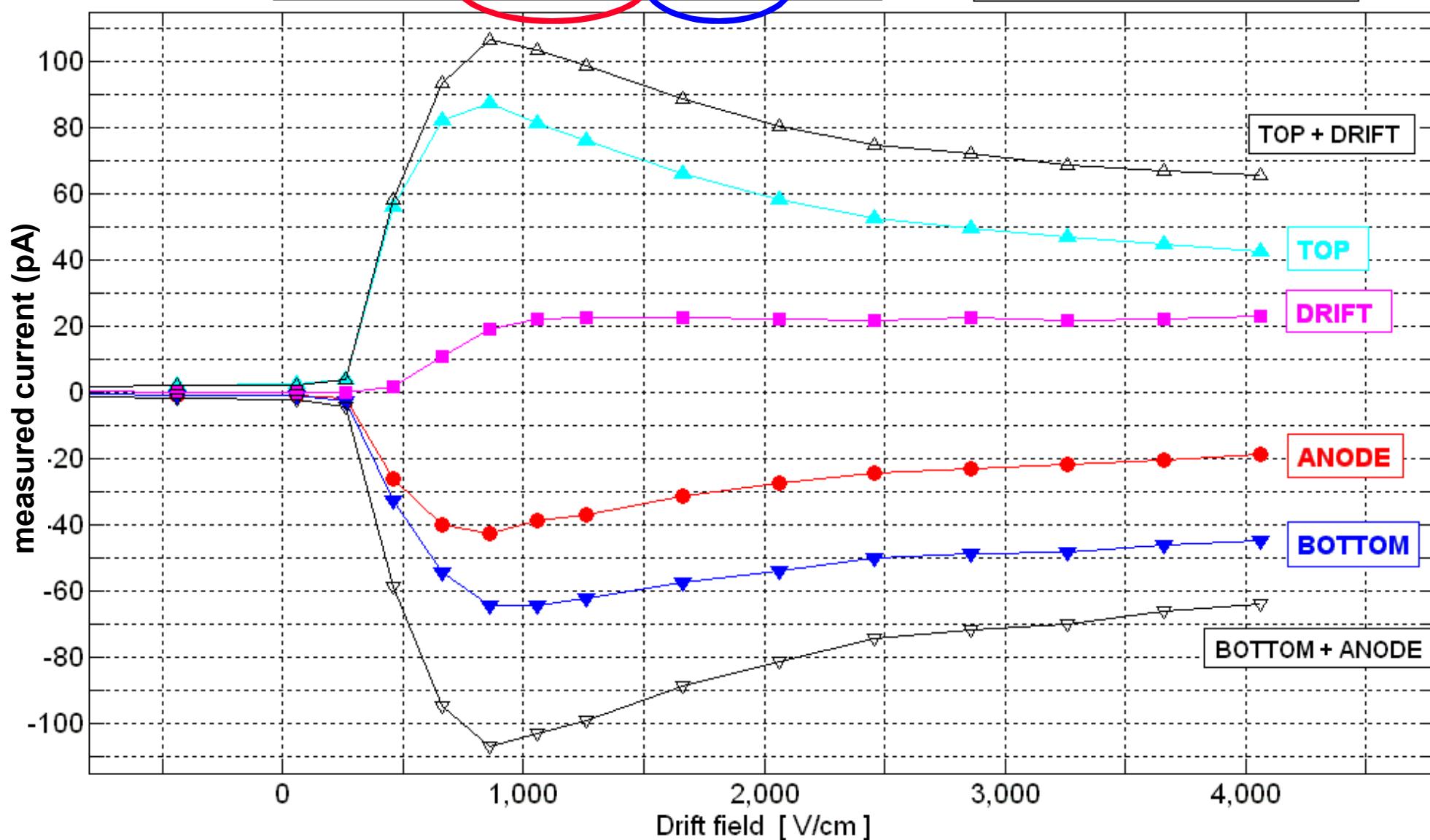
smaller holes: E_{drift} critical for e^- coll. eff.

Drift scan

sample: M2.5

thickness: 0.6mm, diameter: 0.3mm, pitch: 0.8mm, NO RIM

delta-V = 1670 V
Induction field = 3000 V/cm



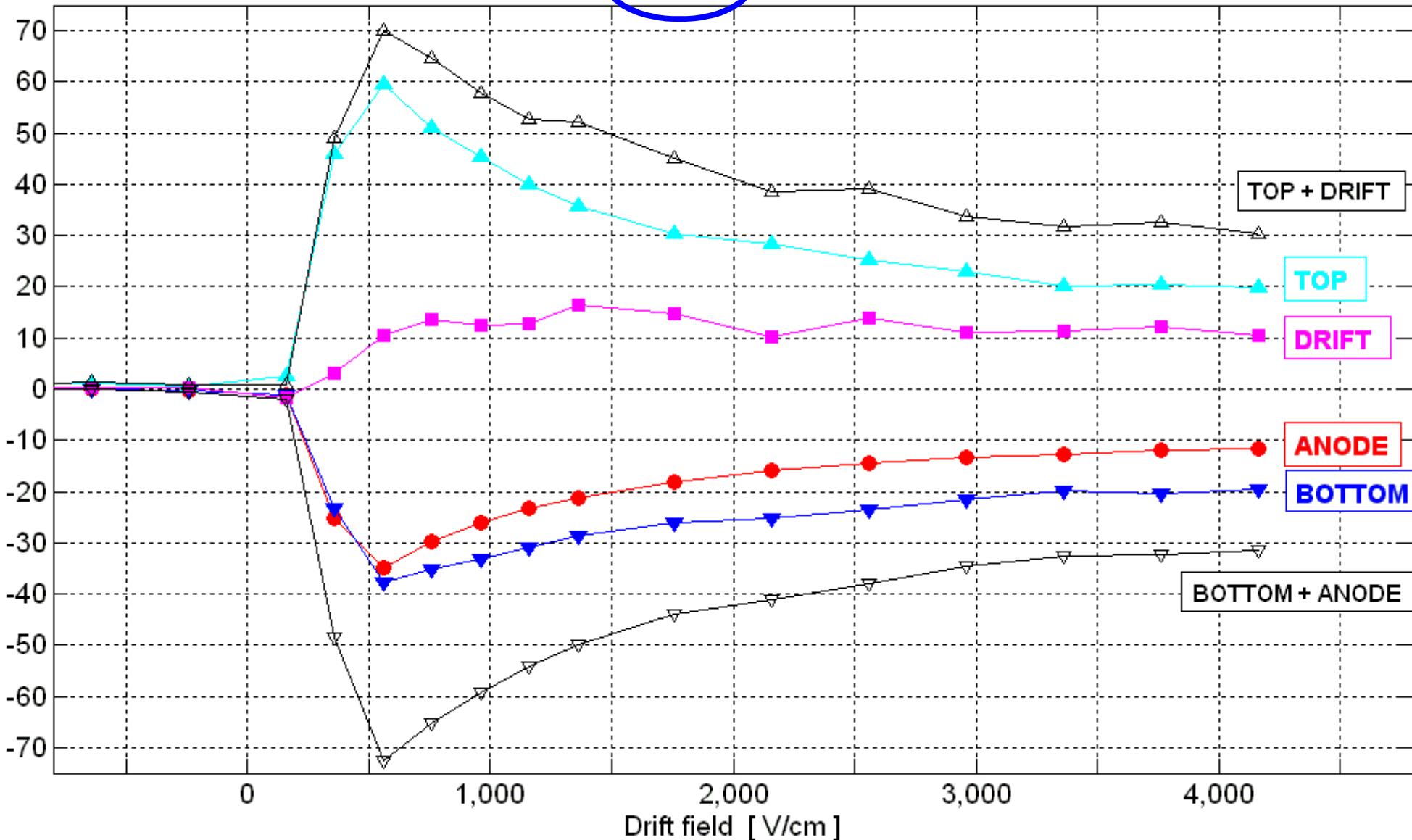
e⁻ collection efficiency

Drift scan

sample: M2.7

thickness: 0.6mm, diameter: 0.3mm, pitch: 1mm, NO RIM

delta-V = 1720 V
Induction field = 3000 V/cm



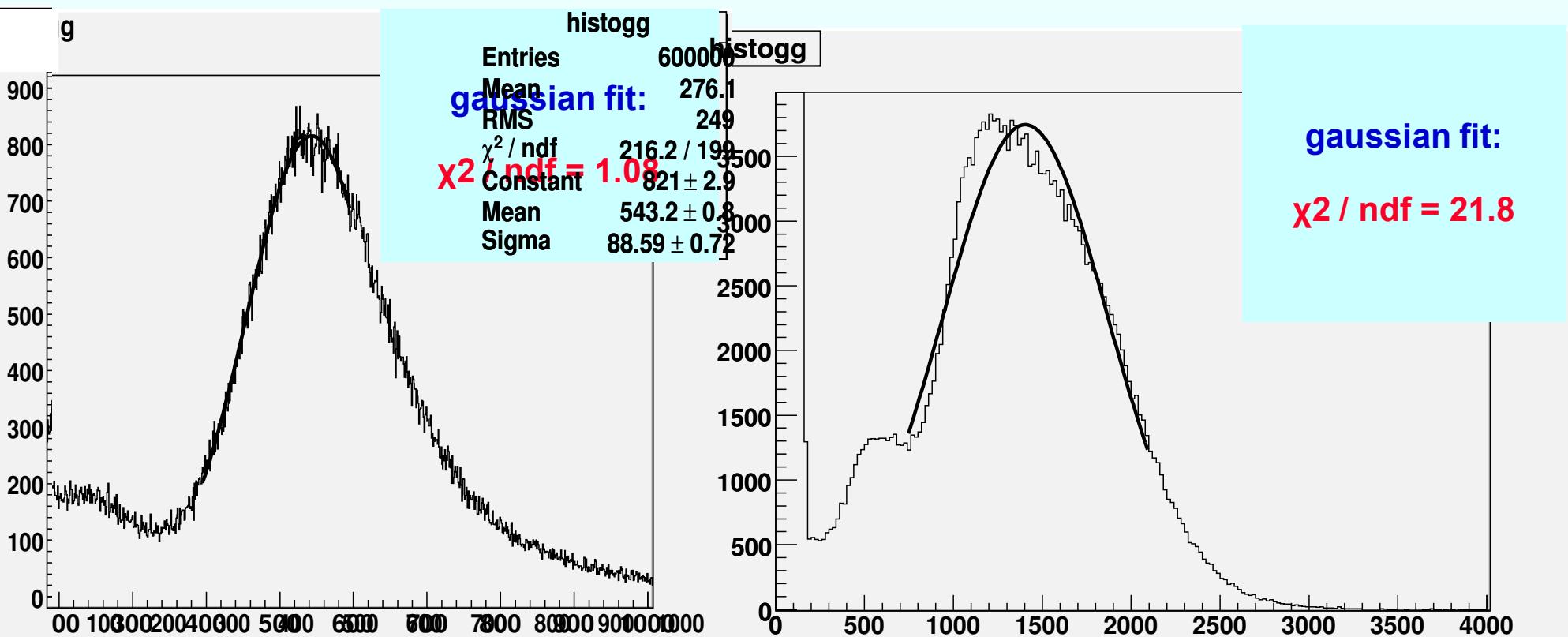
e⁻ collection efficiency

Single THGEM

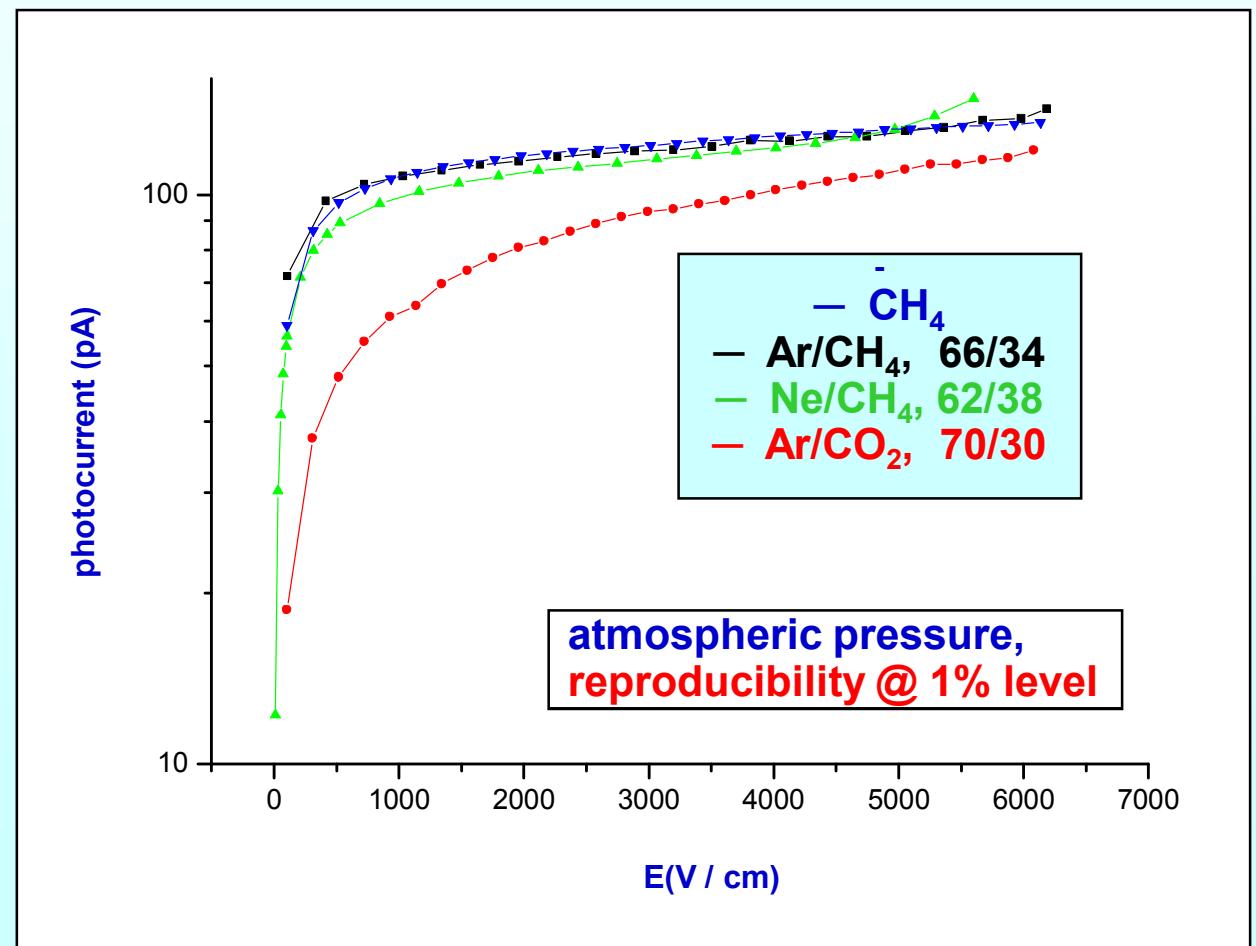
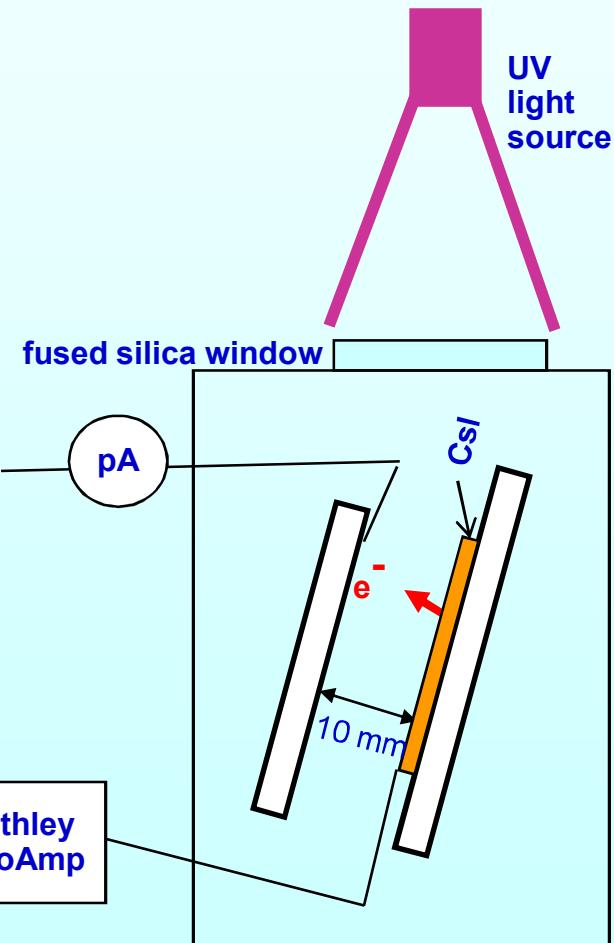
For larger values of the drift field primaries are lost:

currents are lower and spectra become wider and distorted (not gaussian)

This effect is more critical for small values of the hole diameter and large values of the pitch



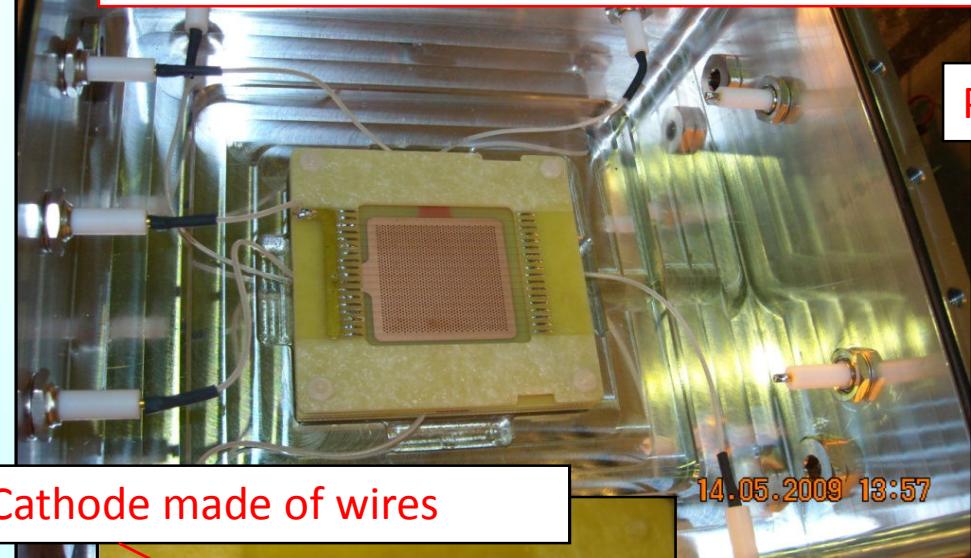
Photocurrent measurements in various gas atmospheres



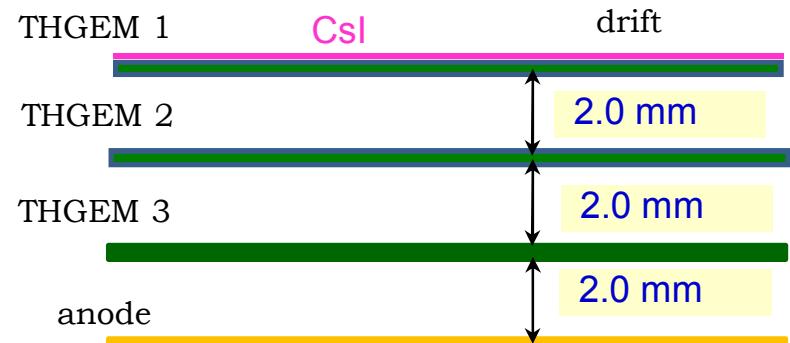
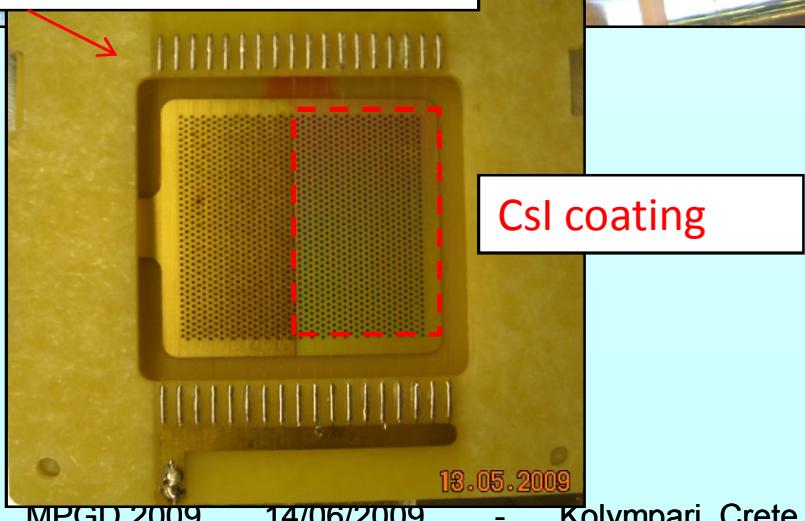
Setup for single photon detection test

Triple THGEM (CsI) Ar/CH₄ 50/50

Diam=0.4 mm, pitch =0.8, Thick=0.4, rim \leq 10 μ m



Pulsed Diode Laser



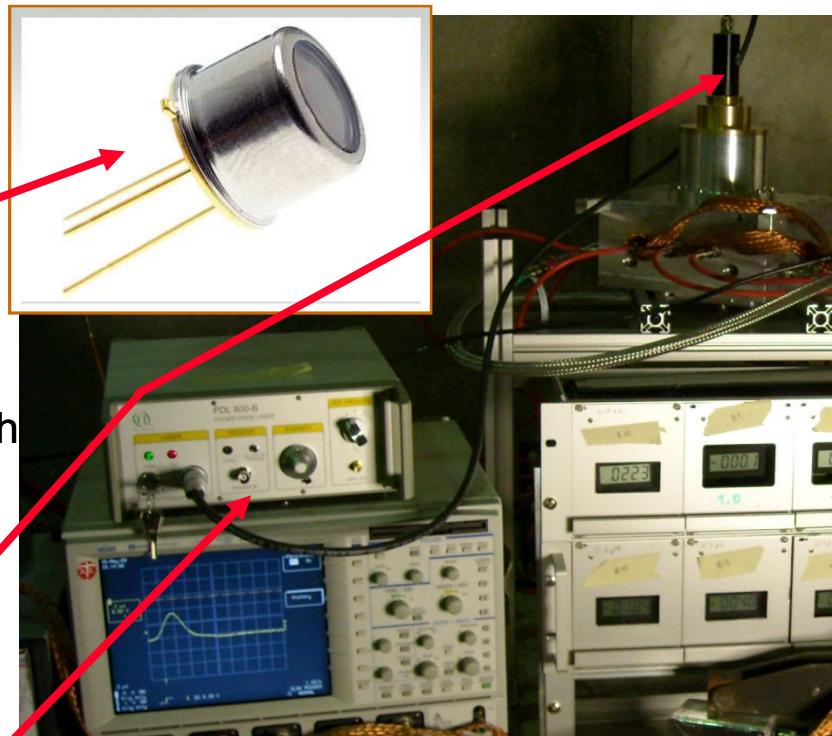
Geometrical sketch inside the chamber

UV LIGHT PULSED SOURCES

1. Model UV LED-255

by Seoul Optodevice Co., Ltd, Seoul, Korea (South)

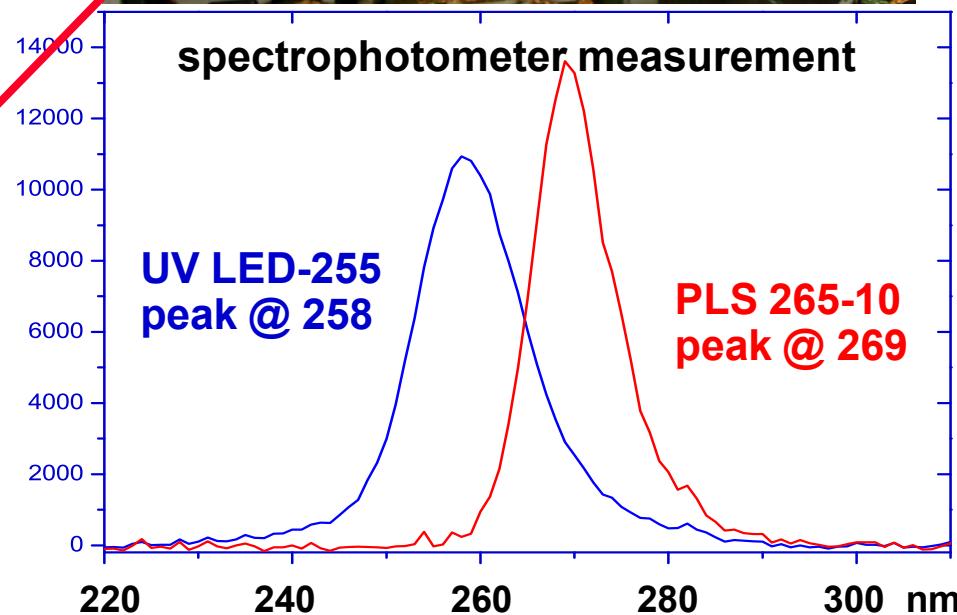
- **Central wavelength $255 \pm 10 \text{ nm}$**
- **Spectral line width: <20nm FWHM**
 - also called germicidal ray (disinfection)
 - Applications: Water/Surface purification, Laboratory testing



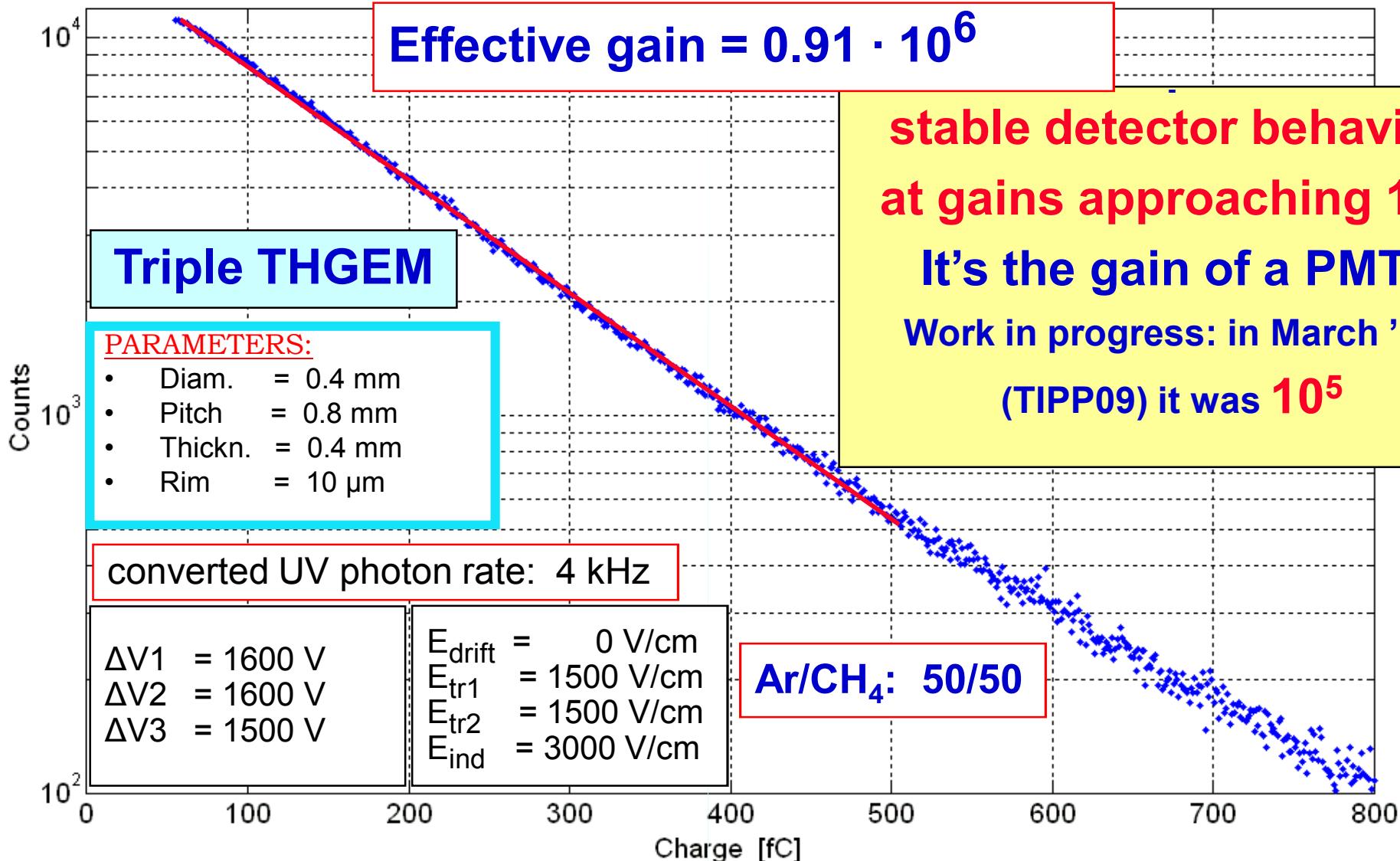
2. PLS 265-10 (pulsed LED) and controller

by PicoQuant GmbH, Berlin, Germany

- **600 ps long pulses**
- **up to 40 MHz**



Amplitude distribution for single photon signals



Time distribution for single photon signals

Triple THGEM

Ar/CH₄: 50/50

gain $\sim 5 \cdot 10^5$

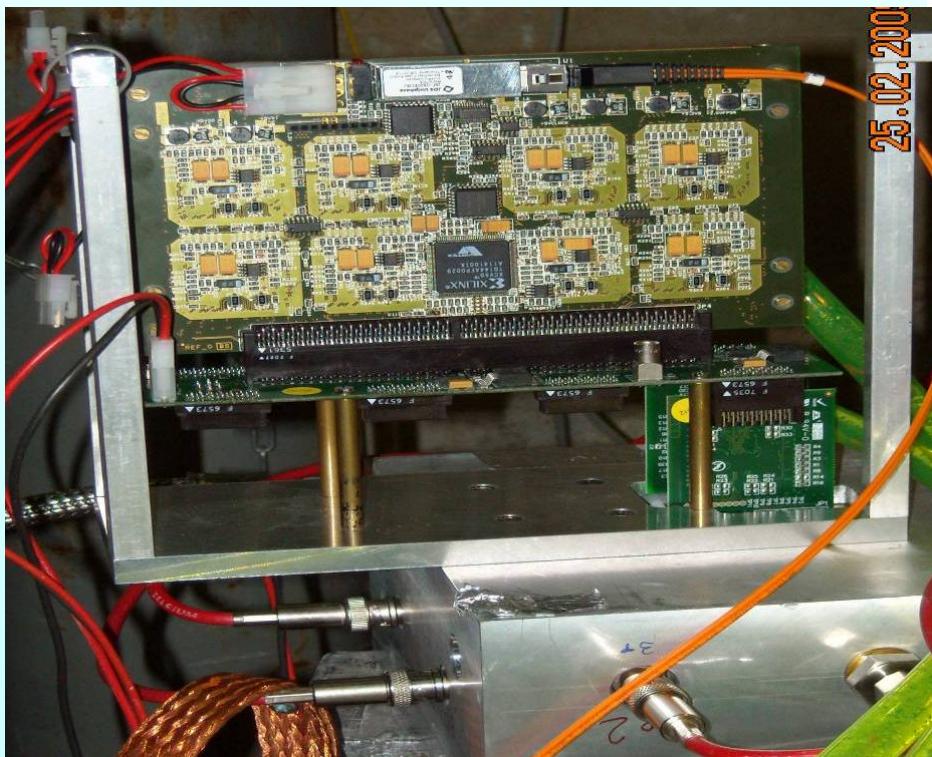
PARAMETERS:

Diam. = 0.4 mm
Pitch = 0.8 mm
Thickn. = 0.4 mm
Rim = 10 μm

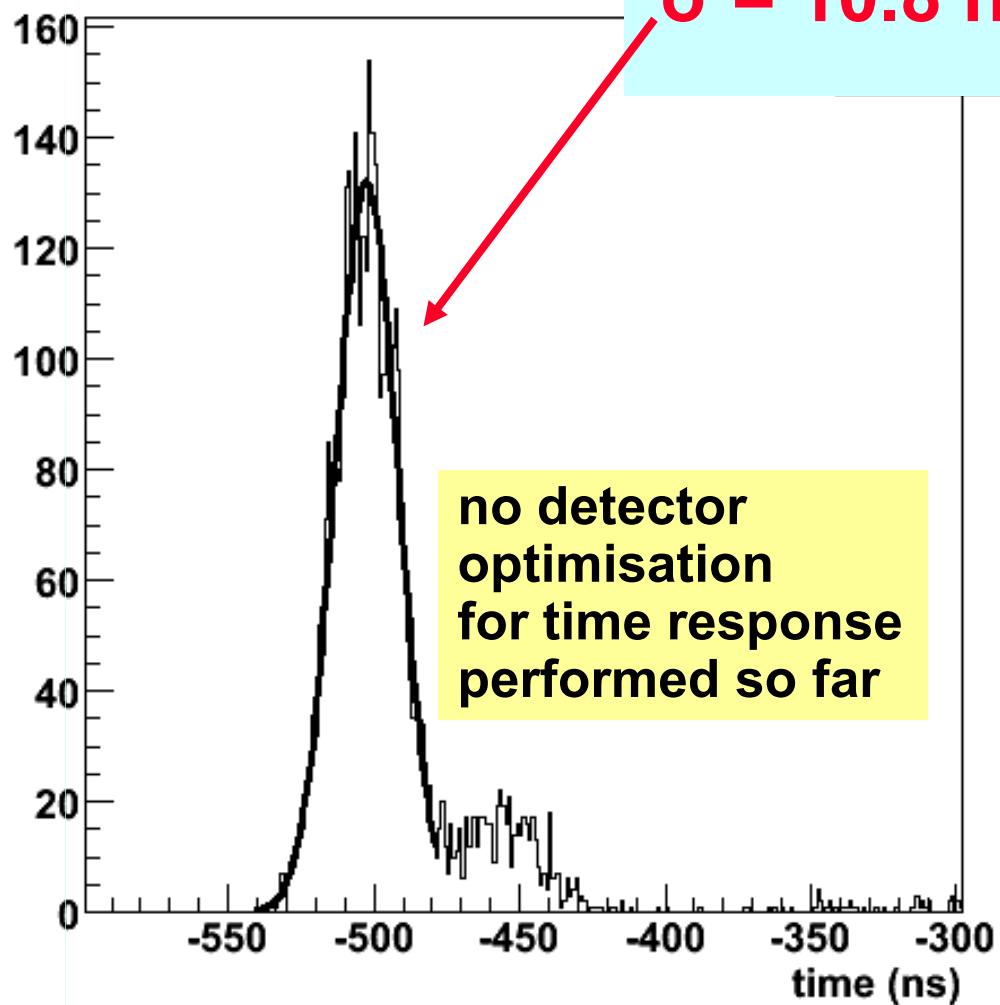
TDC bin size: 108 ps
pulse width: 600 ps

$\sigma = 10.8 \text{ ns}$

converted UV photon rate: 3 kHz

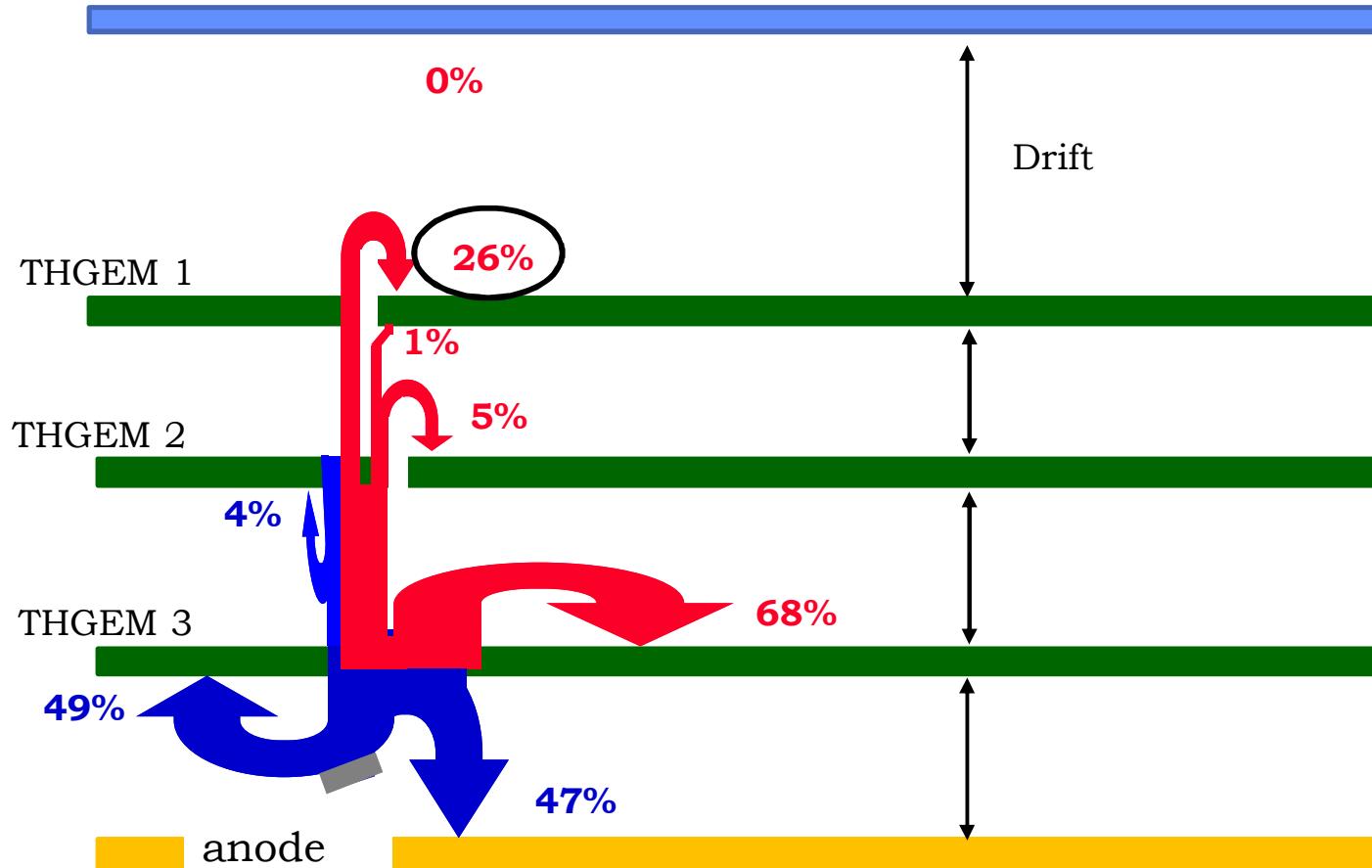


MPGD 2009, 14/06/2009 - Kolympari, Crete



presently typical charge sharing

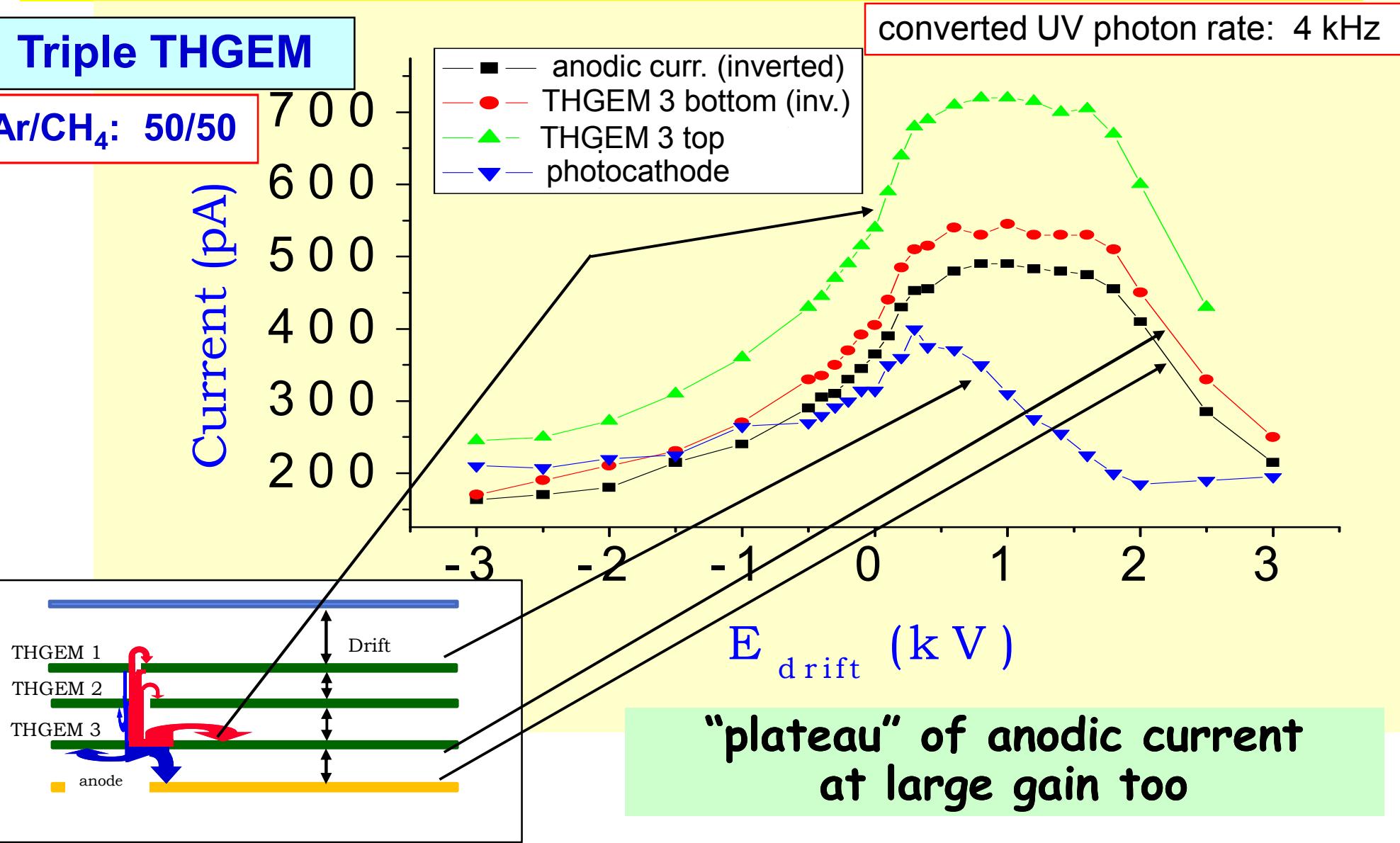
drift



currents as function of E_{drift} at gain $\sim 10^6$

Triple THGEM

Ar/CH₄: 50/50



simulation of photoelectron extraction, $E_{drift}=0$

photoelectron trajectories from a THGEM photocathode, multiplication switched off

thickness 0.6 mm, diam. 0.4 mm, pitch: 0.8 mm, $\Delta V = 1500$ V

external field above the THGEM : 0

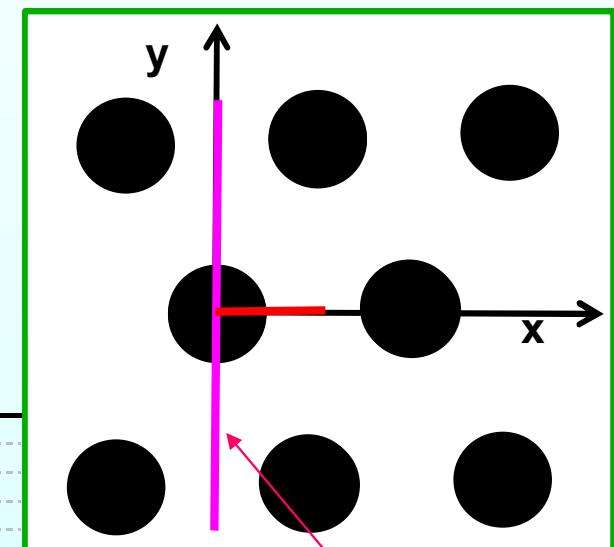
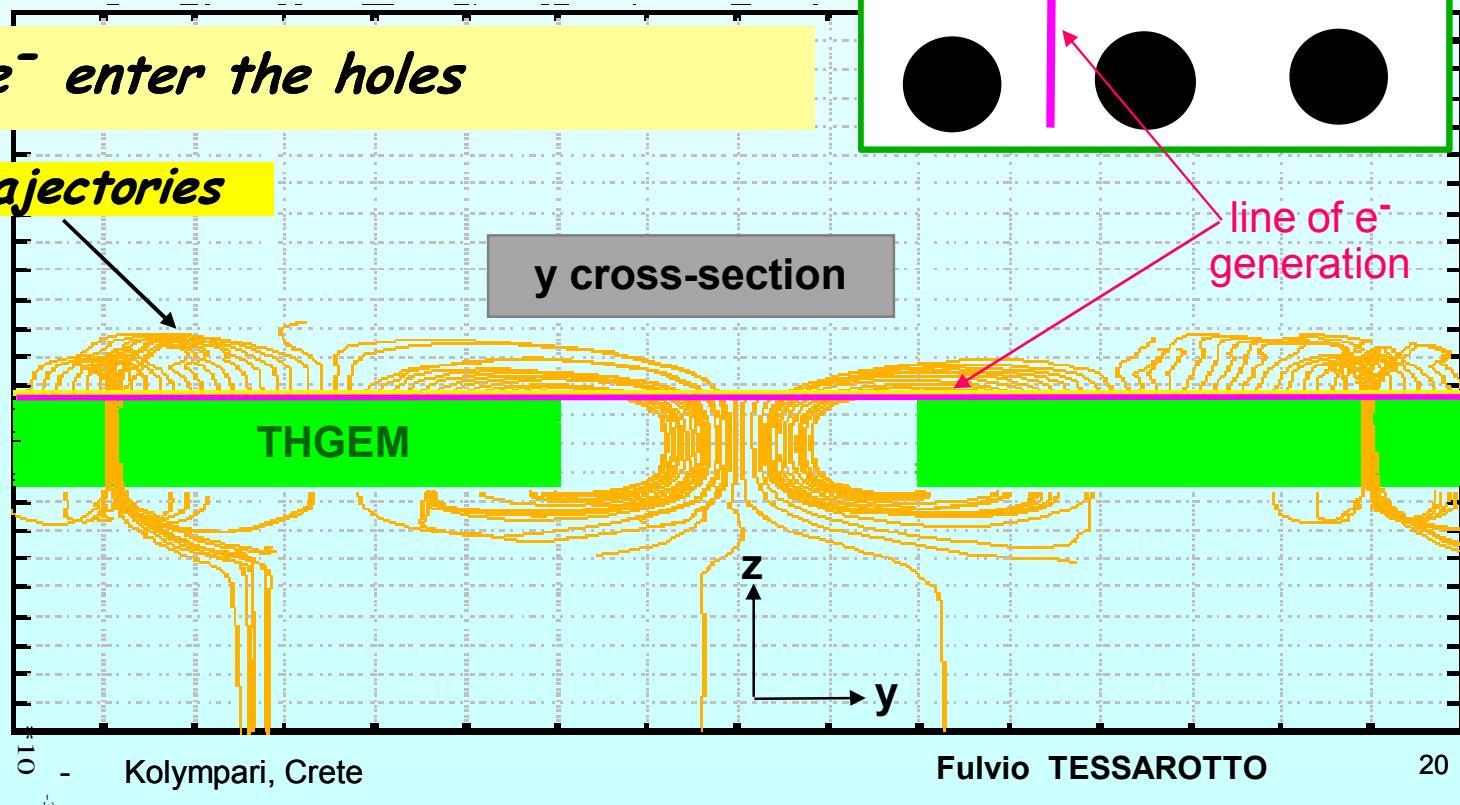
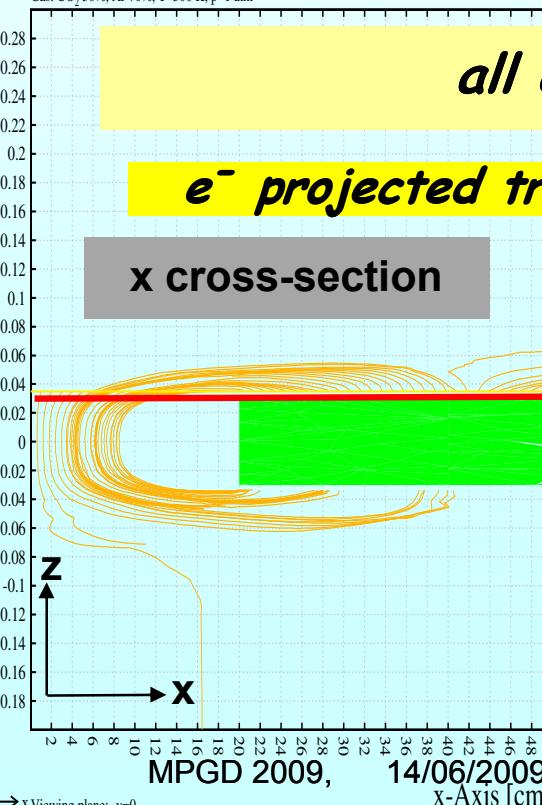
Electron drift lines

Particle: 50 equally spaced points

all e⁻ enter the holes

e⁻ projected trajectories

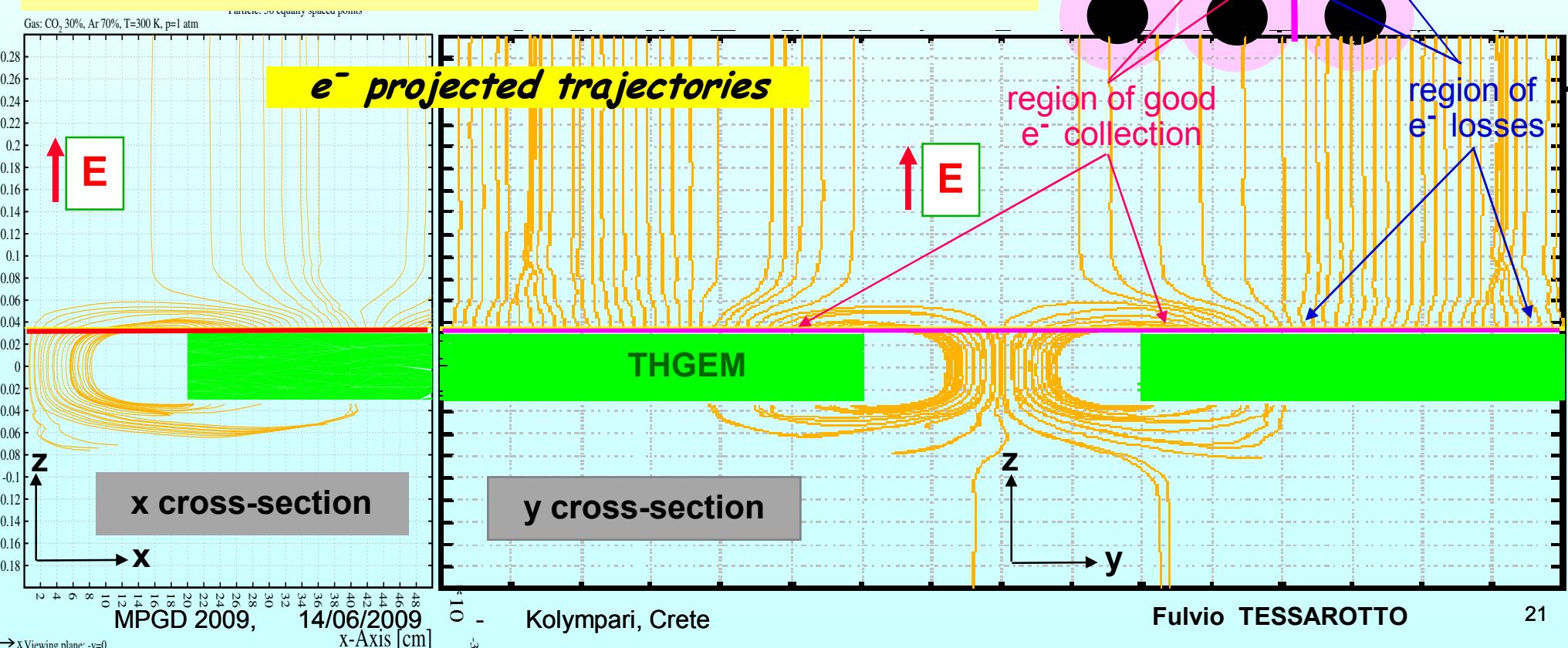
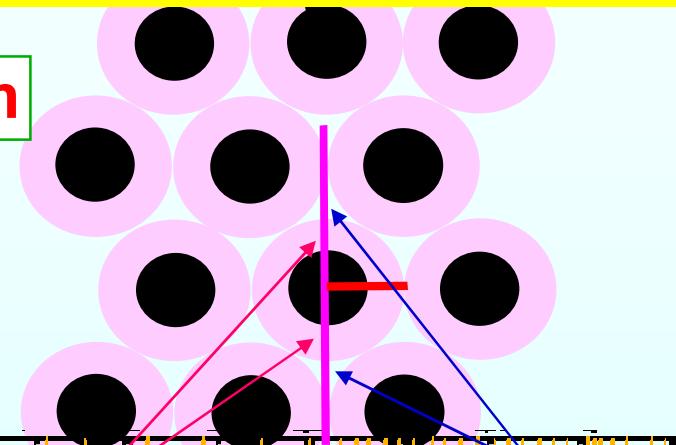
x cross-section



photoelectron trajectories, $E_{drift} = -500$ V/cm

external field above the THGEM : - 500 V/cm

better photoelectron extraction from the CsI
but a fraction of the e^- are lost



photoelectron traj.
 $E_{drift} = +500 \text{ V/cm}$

*lowering field intensity:
 problematic photoelectron
 extraction from CsI*

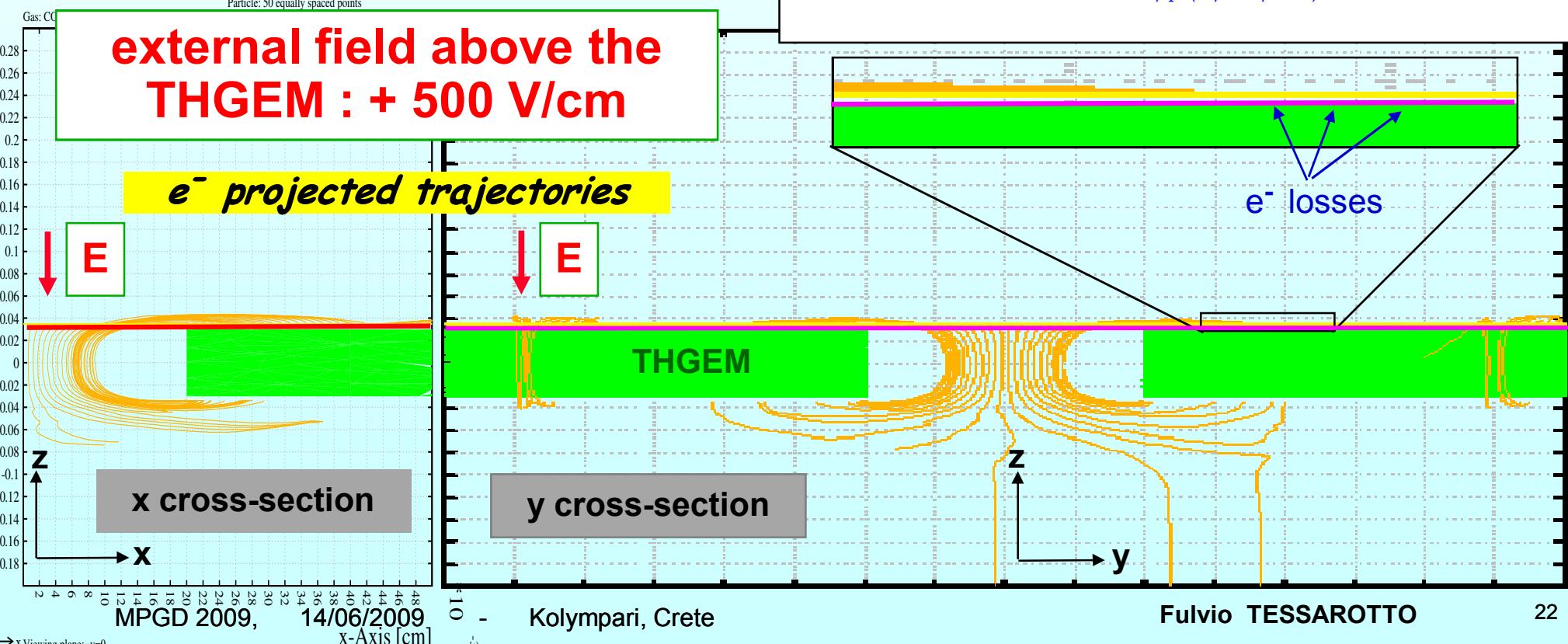
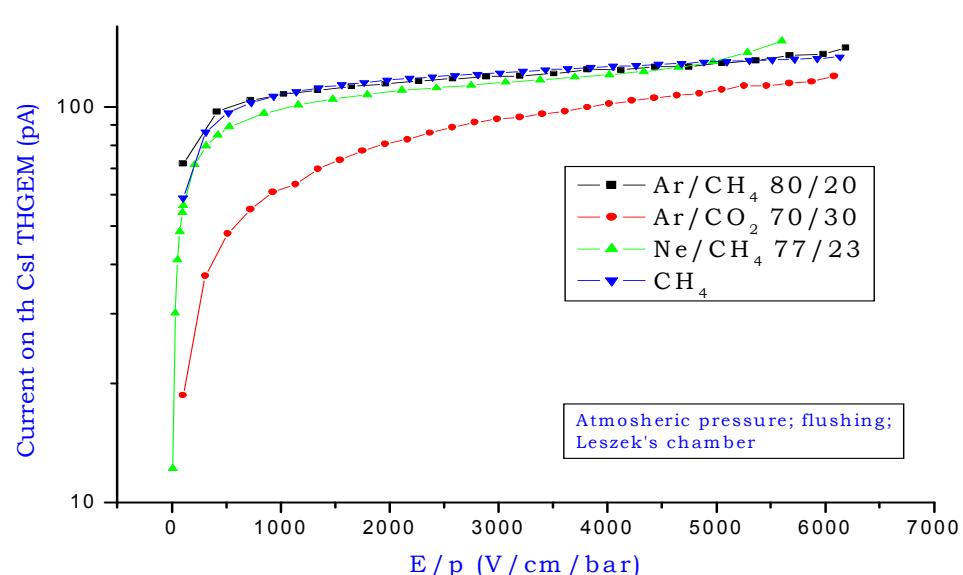
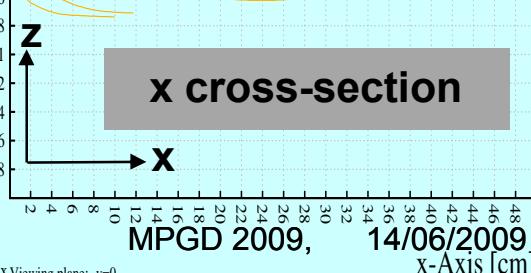
Electron drift times from a track

Particle: 50 equally spaced points

Gas: CO
**external field above the
 THGEM : + 500 V/cm**

e⁻ projected trajectories

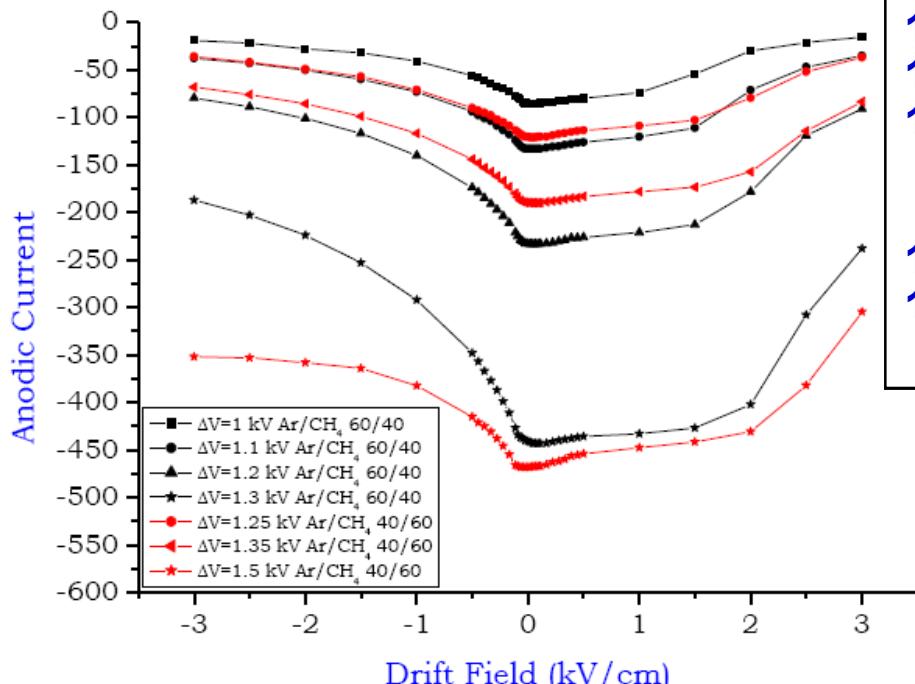
x cross-section



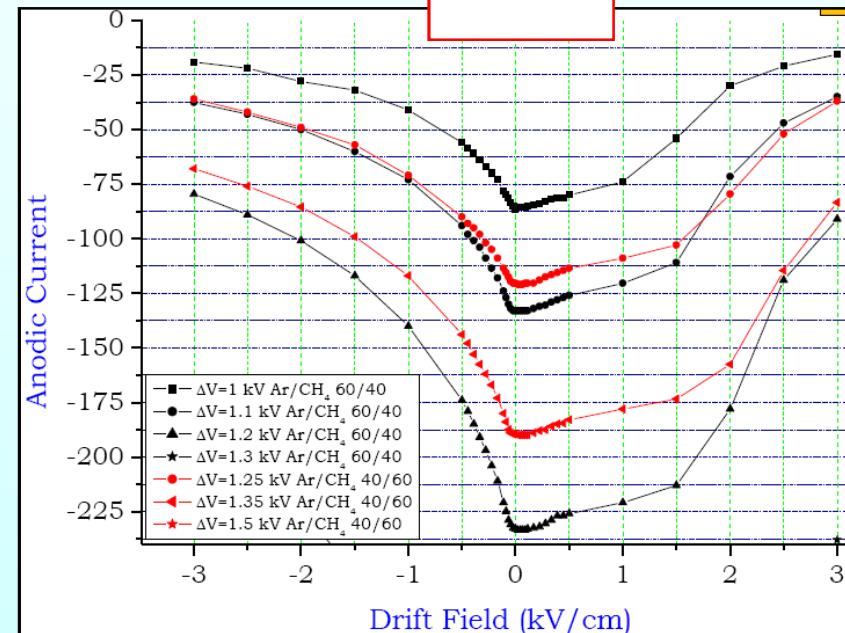
Photoelectron extraction at low THGEM gain

Anodic current in a THGEM detector versus the external electric field applied , a measurement

Ar/CH₄: 40/60; 60/40



$\Delta V =$
1kV
1.1, 1.2
1.25, 1.3
1.35
1.5



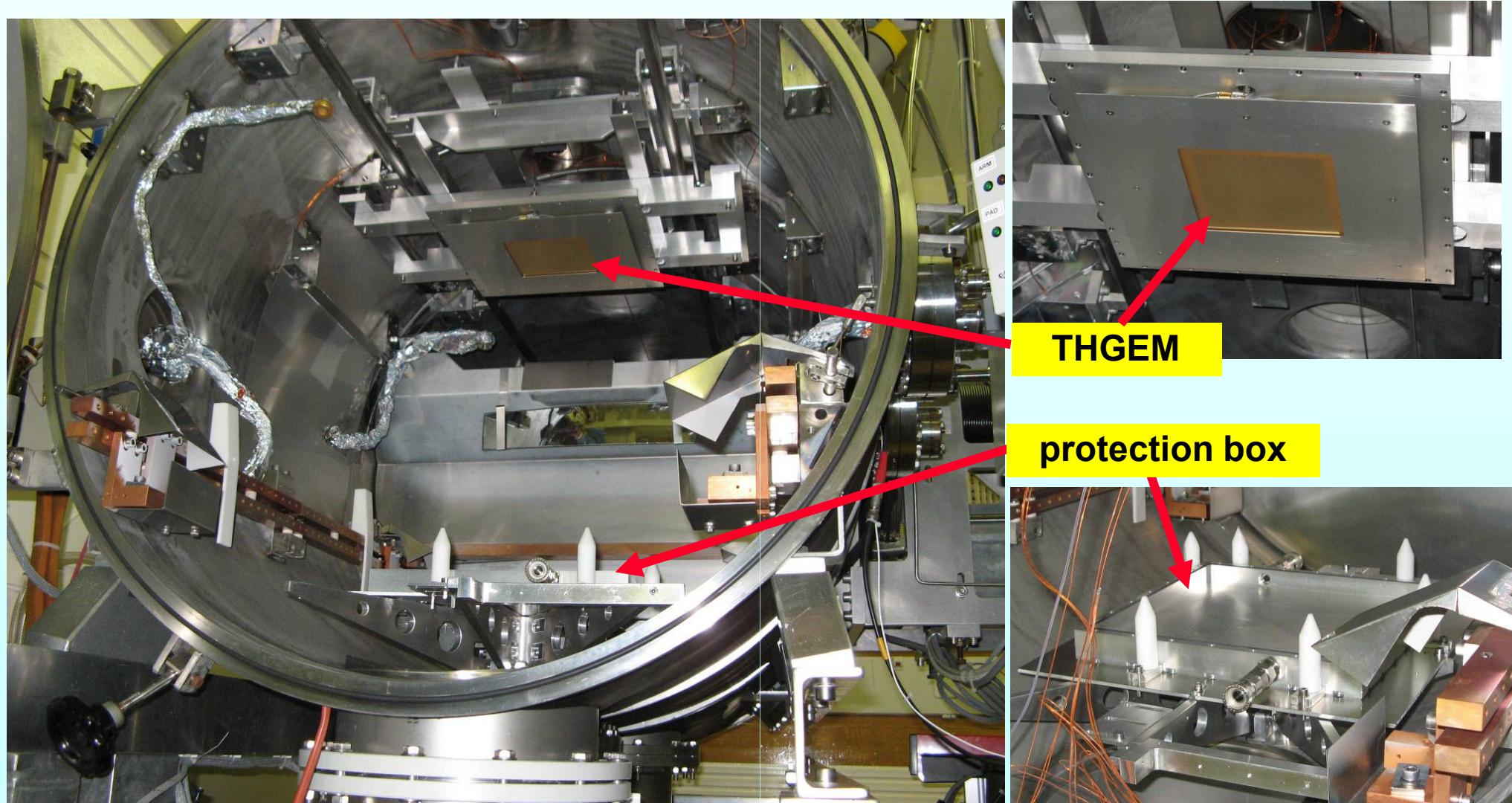
The behaviour predicted by the simulation is confirmed!
→A clear suggestion to optimise the detector design

Perspectives

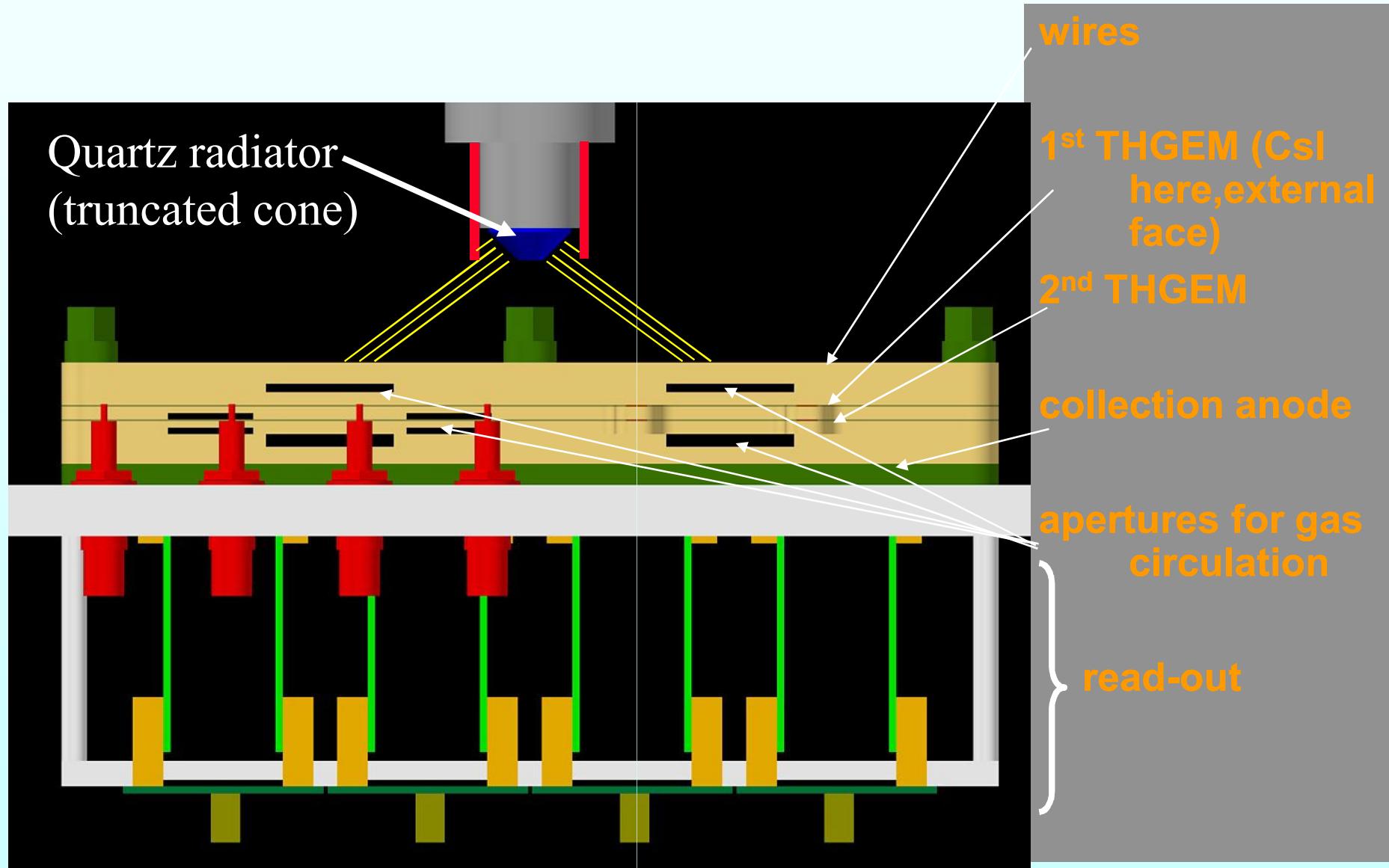
- optimize the parameters of the THGEM with photoconverting CsI layer to achieve the maximum photoelectron collection efficiency
- optimize the parameters for the two THGEMs to be used for the amplification of the signal to provide large and stable gain
- minimize the ion feedback to the CsI photoconverter
- test the chamber with $100 \times 100 \text{ mm}^2$ THGEMs in a real experimental environment
- find solutions for the engineering problems related to the construction of a $600 \times 600 \text{ mm}^2$ test prototype
- assemble and test a first complete “full size” prototype chamber

CsI evaporation on 100 mm x 100 mm THGEM

(A. Braem, C. David, M. van Stenis)

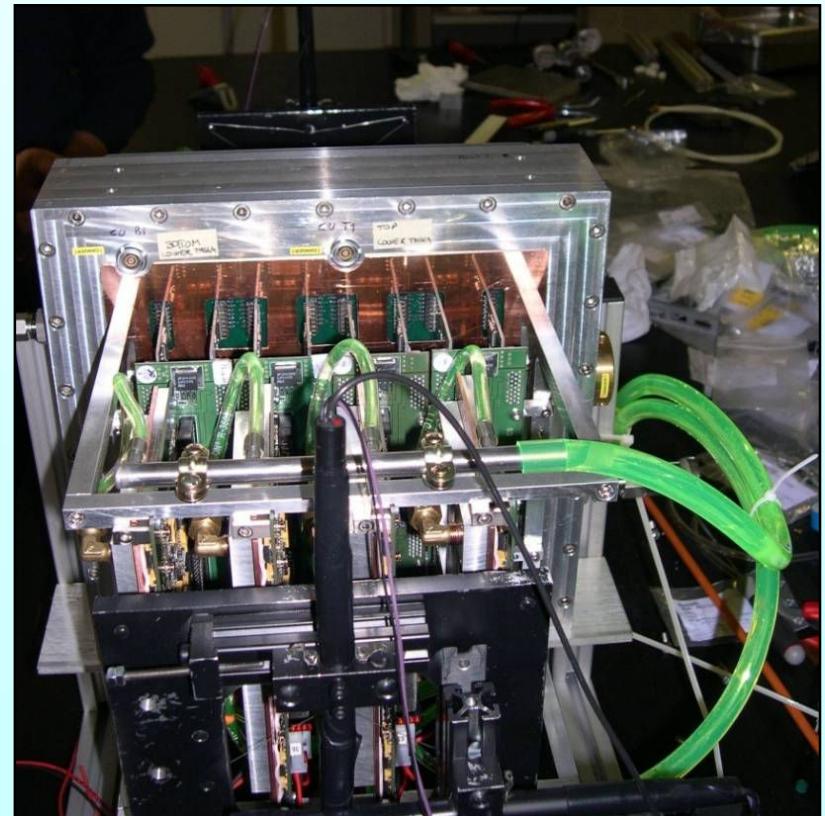
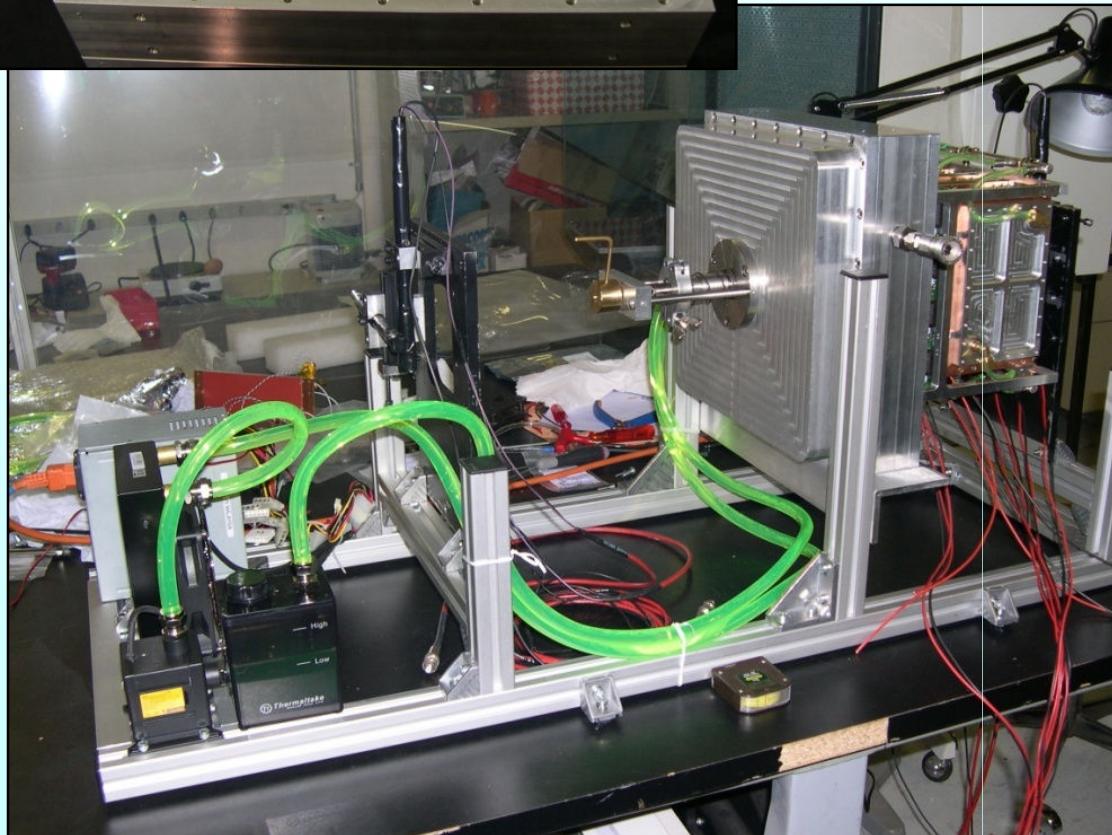
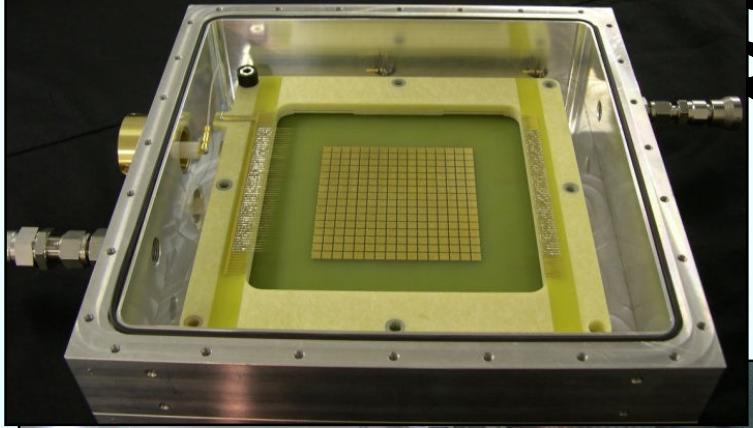


THE 100 × 100 PROTOTYPE STRUCTURE

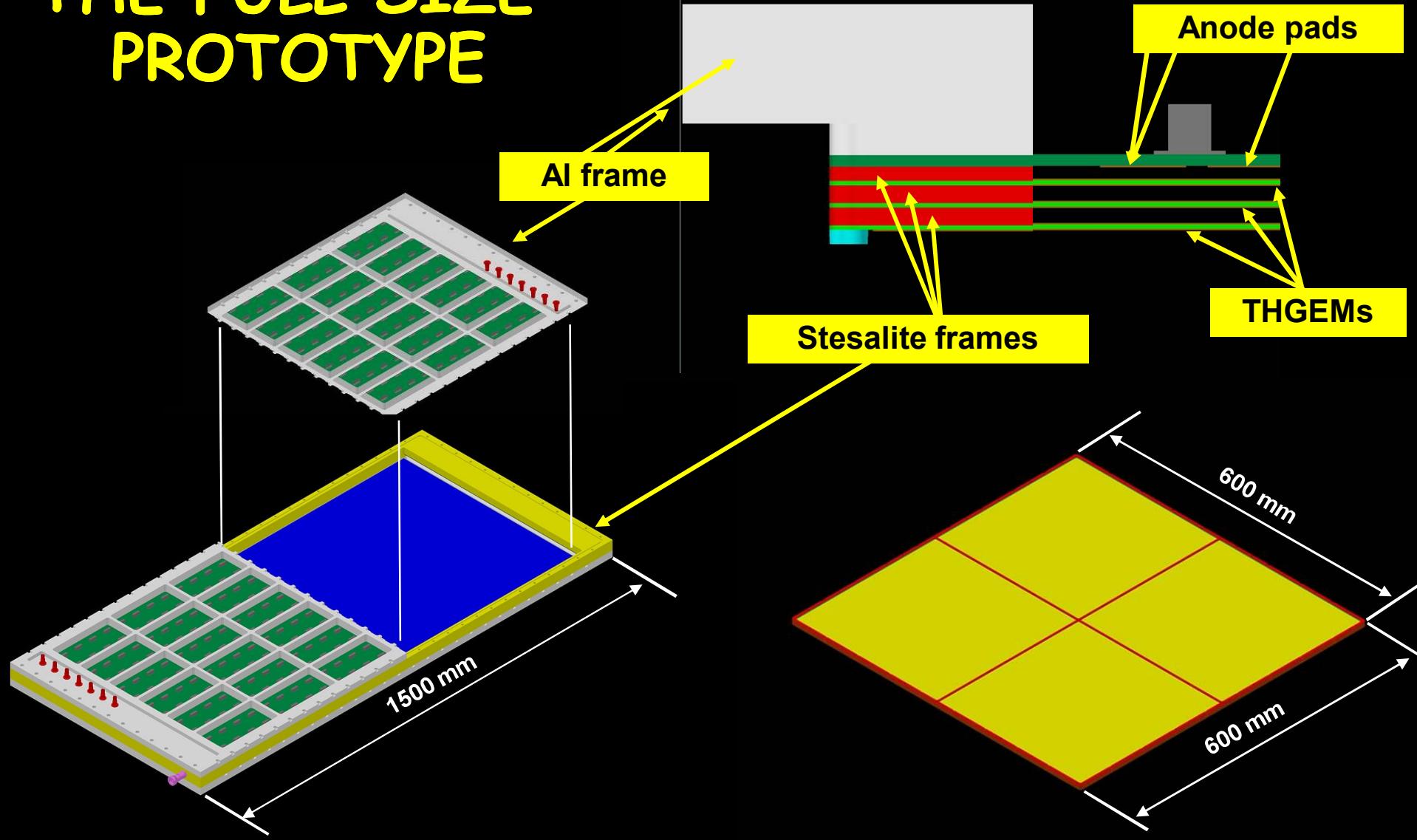


TEST BEAM SET-UP

100 mm x 100 mm ROTOTYPES



THE FULL SIZE PROTOTYPE



Conclusions

- Intense R&D activity towards THGEM-based photon detectors.
- The systematic characterization of more than 30 different THGEM's with X-rays allowed to approach the definition of the best parameters.
- Detection of single photons:
 - gains between 10^5 and 10^6 in electrically stable detectors with $10 \mu\text{m}$ rim and a triple layer structure
 - time resolution $\sim 10 \text{ ns}$
 - effective photoelectron extraction seems possible in methane-rich mixtures
- NO STOPPING POINTS DETECTED, even if still a long way to go
- Medium and large size prototypes are in production

this work is progressing thanks to many colleagues...

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